



ANSI C63.19

TEST REPORT

Product Name	LTE/CDMA 1X/EVDO Mobile Phone with Bluetooth
Model	HUAWEI M920
FCC ID	QISM920
Client	Huawei Technologies Co., Ltd.

TA Technology (Shanghai) Co., Ltd.



TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 2 of 104

GENERAL SUMMARY

Product Name	LTE/CDMA 1X/EVDO Mobile Phone with Bluetooth	Model	HUAWEI M920
FCC ID	QISM920	Report No.	RZA1111-1887HAC01
Client	Huawei Technologies Co., Ltd.		
Manufacturer	Huawei Technologies Co., Ltd.		
Reference Standard(s)	ANSI C63.19-2007: American National Standard Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.		
Conclusion	This portable wireless equipment has been measured in all cases requested by the relevant standards. General Judgment: M4 (RF Emission)  (Stamp) Date of issue: November 24th, 2011		
Comment	The test result only responds to the measured sample.		

Approved by 杨伟中
Director

Revised by 凌敏宝
SAR Manager

Performed by 杨如蔚
SAR Engineer

TABLE OF CONTENT

1. General Information	4
1.1. Notes of the Test Report.....	4
1.2. Testing Laboratory	4
1.3. Applicant Information	5
1.4. Manufacturer Information.....	5
1.5. Information of EUT	6
1.6. The Ambient Conditions during Test.....	8
1.7. The Total M-rating of each tested band	8
1.8. Test Date	8
2. Test Information	9
2.1. Operational Conditions during Test	9
2.1.1. General Description of Test Procedures	9
2.1.2. CDMA Test Configuration	9
2.2. HAC RF Measurements System Configuration.....	10
2.2.1. HAC Measurement Set-up.....	10
2.2.2. Probe System	11
2.2.3. Test Arch Phantom & Phone Positioner	12
2.3. RF Test Procedures.....	13
2.4. System Check.....	15
2.5. Probe Modulation Factor.....	17
2.6. Conducted Output Power Measurement.....	19
3. Test Results	20
3.1. ANSI C63.19-2007 Limits	20
3.2. Summary Test Results.....	21
4. Measurement Uncertainty	23
5. Main Test Instruments	25
ANNEX A: System Check Results.....	26
ANNEX B: Graph Results.....	30
ANNEX C: E-Probe Calibration Certificate	66
ANNEX D: H-Probe Calibration Certificate	76
ANNEX E: CD835V3 Dipole Calibration Certificate.....	86
ANNEX F: CD1880V3 Dipole Calibration Certificate	92
ANNEX G: DAE4 Calibration Certificate.....	98
ANNEX H: The EUT Appearances and Test Configuration.....	103

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 4 of 104

1. General Information

1.1. Notes of the Test Report

TA Technology (Shanghai) Co., Ltd. guarantees the reliability of the data presented in this test report, which is the results of measurements and tests performed for the items under test on the date and under the conditions stated in this test report and is based on the knowledge and technical facilities available at TA Technology (Shanghai) Co., Ltd. at the time of execution of the test.

TA Technology (Shanghai) Co., Ltd. is liable to the client for the maintenance by its personnel of the confidentiality of all information related to the items under test and the results of the test. This report only refers to the item that has undergone the test.

This report standalone dose not constitute or imply by its own an approval of the product by the certification Bodies or competent Authorities. This report cannot be used partially or in full for publicity and/or promotional purposes without previous written approval of **TA Technology (Shanghai) Co., Ltd.** and the Accreditation Bodies, if it applies.

If the electrical report is inconsistent with the printed one, it should be subject to the latter.

1.2. Testing Laboratory

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TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 5 of 104

1.3. Applicant Information

Company: Huawei Technologies Co., Ltd.
Address: Bantian, Longgang District
City: Shenzhen
Postal Code: 518129
Country: P.R. China
Contact: Liu Ye
Telephone: 0755-28780808
Fax: 0755-28780808

1.4. Manufacturer Information

Company: Huawei Technologies Co., Ltd.
Address: Bantian, Longgang District
City: Shenzhen
Postal Code: 518129
Country: P.R. China
Telephone: 0755-28780808
Fax: 0755-28780808

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 6 of 104

1.5. Information of EUT

General Information

Device Type:	Portable Device		
State of Sample:	Prototype Unit		
Product Name:	LTE/CDMA 1X/EVDO Mobile Phone with Bluetooth		
MEID:	99000091000483		
Hardware Version:	Ver.A		
Software Version:	M920V100R001C177B202SP08		
Antenna Type:	Internal Antenna		
Device Operating Configurations:			
Supporting Mode(s):	CDMA Cellular/CDMA PCS/CDMA AWS; (tested)		
	LTE Band II/ LTE Band IV; (untested)		
	WiFi; (untested)		
	Bluetooth; (untested)		
Test Modulation:	QPSK		
Operating Frequency Range(s):	Mode	Tx (MHz)	Rx (MHz)
	CDMA Cellular	824.7 ~ 848.31	869.7 ~ 893.31
	CDMA PCS	1851.25 ~ 1908.75	1931.25 ~ 1988.75
	CDMA AWS	1711.25 ~ 1752.5	2111.25 ~ 2152.5
Test Channel: (Low - Middle - High)	1013 - 384 - 777 25 - 600 - 1175 25 - 450 - 850	(CDMA Cellular) (CDMA PCS) (CDMA AWS)	(tested) (tested) (tested)
Power Class:	CDMA Cellular: Tested with Power Control All up bits		
	CDMA PCS: Tested with Power Control All up bits		
	CDMA AWS: Tested with Power Control All up bits		

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 7 of 104

Auxiliary Equipment Details

AE1:Battery

Model: HB5F1H

Manufacturer: Huawei Technologies Co., Ltd.

S/N: LKCB8166I32D1330

Equipment Under Test (EUT) is a model of LTE/CDMA 1X/EVDO Mobile Phone with Bluetooth. The detail about Mobile phone and Lithium Battery is in chapter 1.5 in this report. The EUT has a CDMA/LTE antenna that is used for Tx/Rx, and the other is BT/WIFI antenna that is used for Tx/Rx. HAC RF emission is tested for CDMA Cellular, CDMA PCS and CDMA AWS in this report. WiFi, Bluetooth, LTE Band II and LTE Band IV modes don't have voice capability, so do not operate in the held to ear mode for providing handset service.

The sample under test was selected by the Client.

Components list please refer to documents of the manufacturer.

Air-Interface	Band (MHZ)	Type	C63.19/ tested	Simultaneous Transmissions Note:Not to be tested	Concurrent single transmission	Reduced power 20.19(c) (1)	Voice Over Digital Transport (Data)
CDMA	800	VO	Yes	YES WIFI or BT	Yes:EVDO, LTE, WIFI Not rated	NA	NA
	1700	VO	Yes			NA	
	1900	VO	Yes			NA	
	EVDO	DT	NA	YES BT	Yes:*see note	NA	Yes
LTE	1700	DT	NA	YES WIFI or BT	Yes:*see note	NA	Yes
	1900						
WIFI	2400	DT	NA	YES CDMA or LTE	NA	NA	Yes
Bluetooth(BT)	2400	DT	NA	YES CDMA/EVDO or LTE	NA	NA	NA

VO Voice CMRS/PSTN Service Only
V/D Voice CMRS/PSTN and Data Service
DT Digital Transport

*HAC Rating was not based on concurrent voice and data modes, Non current mode was found to represent worst case rating. for

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 8 of 104

1.6. The Ambient Conditions during Test

Temperature	Min. = 18°C, Max. = 28 °C
Relative humidity	Min. = 0%, Max. = 80%
Ground system resistance	< 0.5 Ω
Ambient noise is checked and found very low and in compliance with requirement of standards. Reflection of surrounding objects is minimized and in compliance with requirement of standards.	

1.7. The Total M-rating of each tested band

Band	Rating
CDMA Cellular	M4
CDMA PCS	M4
CDMA AWS	M4

1.8. Test Date

The test is performed on November 11, 2011.

2. Test Information

2.1. Operational Conditions during Test

2.1.1. General Description of Test Procedures

The phone was tested in all normal configurations for the ear use. The EUT is mounted in the device holder equivalent as for classic dosimeter measurements. The acoustic output of the EUT shall coincide with the center point of the area formed by the dielectric wire and the middle bar of the arch's top frame. The EUT shall be moved vertically upwards until it touches the frame. The fine adjustment is possible by sliding the complete. The EUT holder is on the yellow base plate of the Test Arch phantom. These test configurations are tested at the high, middle and low frequency channels of each applicable operating mode; for example, GSM, WCDMA (UMTS), CDMA and TDMA.

2.1.2. CDMA Test Configuration

A communication link is set up with a System Simulator (SS) by air link, and a call is established. The Absolute Radio Frequency Channel Number (ARFCN) are allocated to 1013, 384 and 777 respectively in the case of CDMA Cellular, allocated to 25, 600 and 1175 respectively in the case of CDMA PCS, allocated to 25, 450 and 850 respectively in the case of CDMA AWS, The EUT is commanded to operate at maximum transmitting power.

Test Parameter setup for maximum RF output power according to section 4.4.5 of 3GPP2.

Parameter	Units	Value
I or	dBm/1.23MHz	-104
PilotE c /I or	dB	-7
TrafficE c /I or	dB	-7.4

2.2. HAC RF Measurements System Configuration

2.2.1. HAC Measurement Set-up

These measurements are performed using the DASY5 automated dosimetric assessment system. It is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland. It consists of high precision robotics system (Stäubli), robot controller, Intel Core2 computer, near-field probe, probe alignment sensor. The robot is a six-axis industrial robot performing precise movements. Cell controller systems contain the power supply, robot controller, teach pendant (Joystick) and remote control, and are used to drive the robot motors. The Stäubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit performs the signal amplification; signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

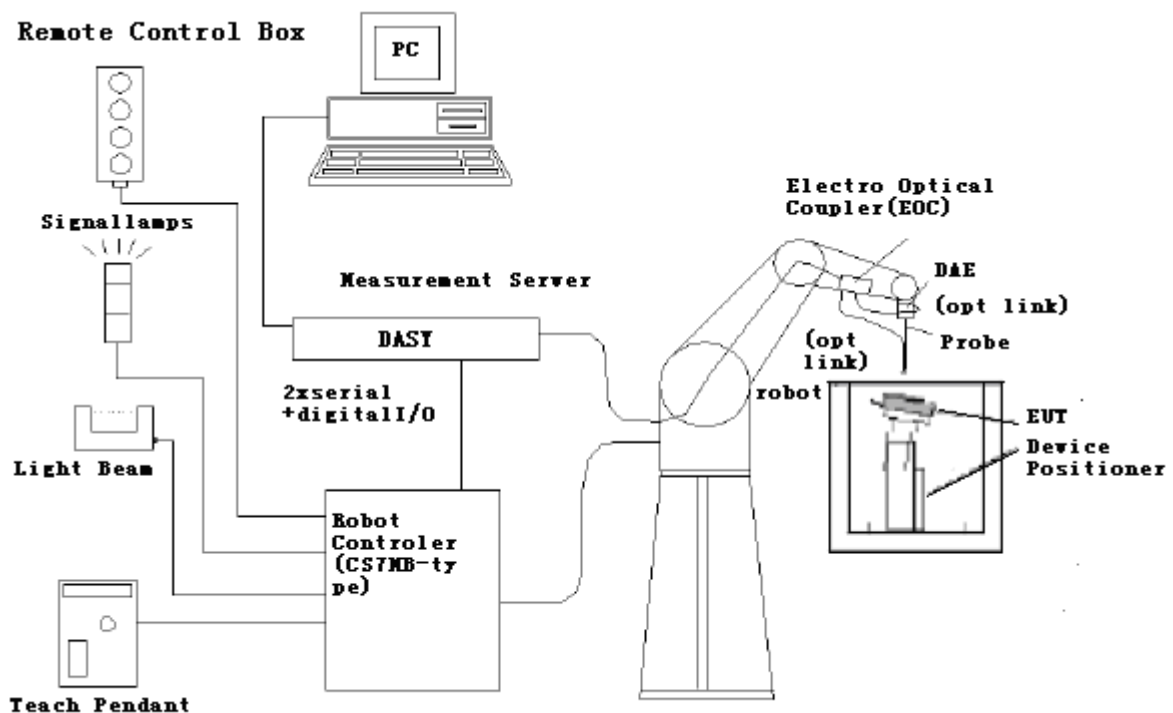


Figure 1 HAC Test Measurement Set-up

The DAE4 consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.

2.2.2. Probe System

The HAC measurements were conducted with the E-Field Probe ER3DV6 and the H-Field Probe H3DV6 (manufactured by SPEAG), designed in the classical triangular configuration and optimized for dosimetric evaluation.

E-Field Probe Description

Construction	One dipole parallel, two dipoles normal to probe axis Built-in shielding against static charges PEEK enclosure material
Calibration	In air from 100 MHz to 3.0 GHz (absolute accuracy $\pm 6.0\%$, $k=2$)
Frequency	40 MHz to > 6 GHz (can be extended to < 20 MHz) Linearity: ± 0.2 dB (100 MHz to 3 GHz)
Directivity	± 0.2 dB in air (rotation around probe axis) ± 0.4 dB in air (rotation normal to probe axis)
Dynamic Range	2 V/m to > 1000 V/m; Linearity: ± 0.2 dB
Dimensions	Overall length: 330 mm (Tip: 16 mm) Tip diameter: 8 mm (Body: 12 mm) Distance from probe tip to dipole centers: 2.5 mm
Application	General near-field measurements up to 6 GHz Field component measurements Fast automatic scanning in phantoms



Figure 2 ER3DV6 E-field Probe

H-Field Probe Description

Construction	Three concentric loop sensors with 3.8 mm loop diameters Resistively loaded detector diodes for linear response Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., glycolether)
Frequency	200 MHz to 3 GHz (absolute accuracy $\pm 6.0\%$, $k=2$); Output linearized
Directivity	± 0.2 dB (spherical isotropy error)
Dynamic Range	10 mA/m to 2 A/m at 1 GHz
E-Field Interference	< 10% at 3 GHz (for plane wave)
Dimensions	Overall length: 330 mm (Tip: 40 mm) Tip diameter: 6 mm (Body: 12 mm) Distance from probe tip to dipole centers: 3 mm



Figure 3 H3DV6 H-field Probe

Application	General magnetic near-field measurements up to 3 GHz (in air or liquids) Field component measurements Surface current measurements Low interaction with the measured field
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2.2.3. Test Arch Phantom & Phone Positioner

The Test Arch phantom should be positioned horizontally on a stable surface. Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot. It enables easy and well defined positioning of the phone and validation dipoles as well as simple teaching of the robot (Dimensions: 370 x 370 x 370 mm).

The Device reference point is set for the EUT at 6.3 mm, the Grid reference point is on the upper surface at the origin of the coordinates, and the “user point \Height Check 0.5 mm” is 0.5mm above the center, allowing verification of the gap of 0.5mm while the probe is positioned there.

The Phone Positioner supports accurate and reliable positioning of any phone with effect on near field $<\pm 0.5$ dB.

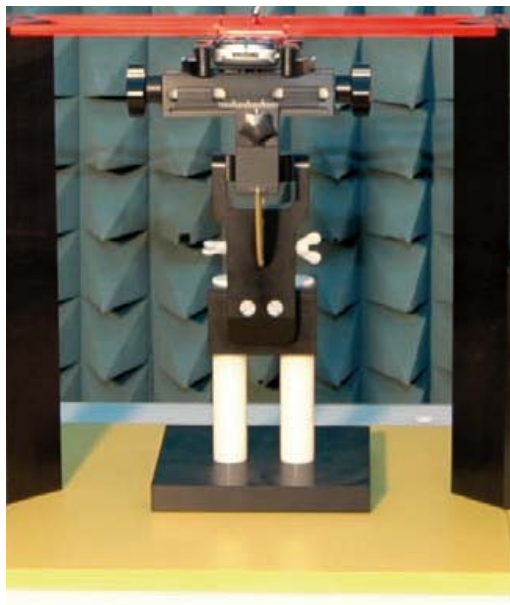


Figure 4 HAC Phantom & Device Holder

2.3. RF Test Procedures

The evaluation was performed with the following procedure:

1. Confirm proper operation of the field probe, probe measurement system and other instrumentation and the positioning system.
2. Position the WD in its intended test position. The gauge block can simplify this positioning. Note that a separate E-field and H-field gauge block will be needed if the center of the probe sensor elements is at different distances from the tip of the probe.
3. Configure the WD normal operation for maximum rated RF output power, at the desired channel and other operating parameters (e.g., test mode), as intended for the test.
4. The center sub-grid shall center on the center of the axial measurement point or the acoustic output, as appropriate. Locate the field probe at the initial test position in the 50 mm by 50 mm grid, which is contained in the measurement plane. If the field alignment method is used, align the probe for maximum field reception.
5. Record the reading.
6. Scan the entire 50 mm by 50 mm region in equally spaced increments and record the reading at each measurement point. The grid is 5 cm by 5 cm area that is divided into 9 evenly sized blocks or sub-grids. The distance between measurement points shall be sufficient to assure the identification of the maximum reading.
7. Identify the five contiguous sub-grids around the center sub-grid with the lowest maximum field strength readings. Thus the six areas to be used to determine the WD's highest emissions are identified and outlined for the final manual scan. Please note that a maximum of five blocks can be excluded for both E-field and H-field measurements for the WD output being measured. Stated another way, the center sub-grid and three others must be common to both the E-field and H-field measurements.
8. Identify the maximum field reading within the non-excluded sub-grids identified in Step 7.
9. Convert the maximum field strength reading identified in Step 8 to V/m or A/m, as appropriate. For probes which require a probe modulation factor, this conversion shall be done using the appropriate probe modulation factor and the calibration.
10. Repeat Step 1 through Step 10 for both the E-field and H-field measurements.
11. Compare this reading to the categories in ANSI C63.19 Clause 7 and record the resulting category. The lowest category number listed in 7.2, Table 7.4, or Table 7.5 obtained in Step 10 for either E- or H-field determines the M category for the audio coupling mode assessment. Record the WD category rating.

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 14 of 104



Figure 5 WD reference and plane for RF emission measurements

2.4. System Check

Validation Procedure

Place a dipole antenna meeting the requirements given in ANSI C63.19 D.5 in the position normally occupied by the WD. The dipole antenna serves as a known source for an electrical and magnetic output. Position the E-field and H-field probes so that:

The probes and their cables are parallel to the coaxial feed of the dipole antenna.

The probe cables and the coaxial feed of the dipole antenna approach the measurement area from opposite directions.

The center point of the probe element(s) are 10 mm from the closest surface of the dipole elements. Validation was performed to verify that measured E-field and H-field values are within +/-25% from the target reference values provided by the manufacturer. "Values within +/-25% are acceptable. Of which 12% is deviation and 13% is measurement uncertainty."

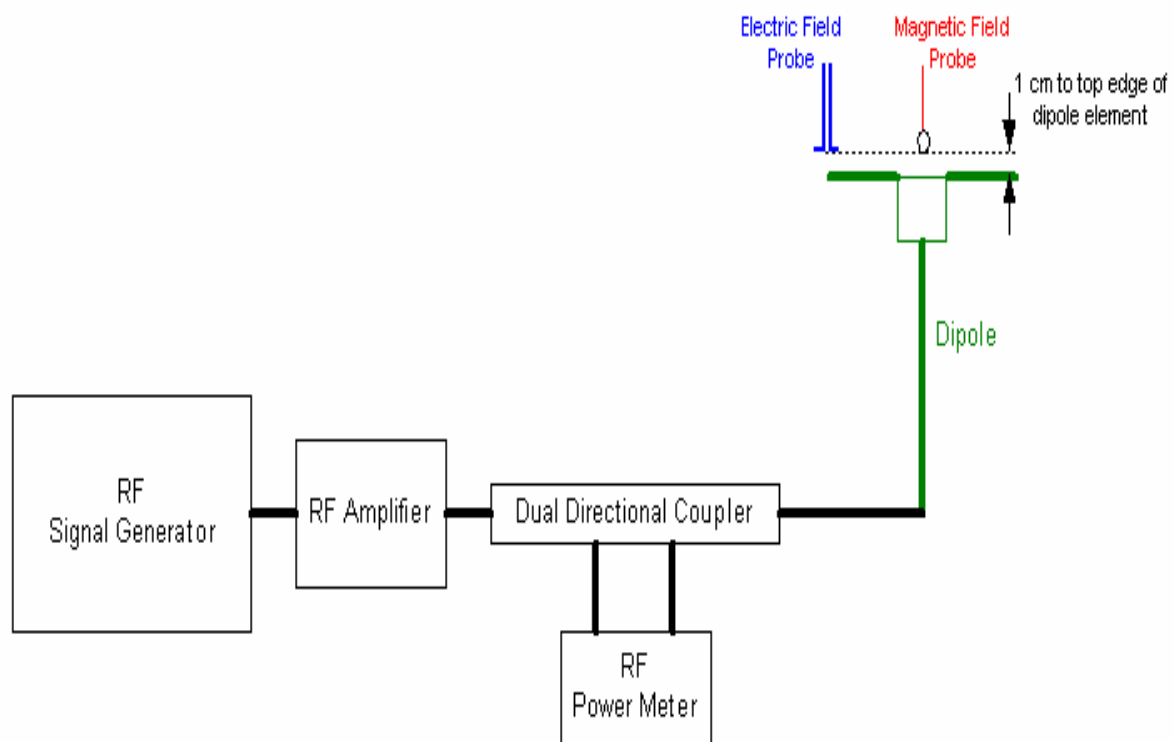


Figure 6 Dipole Validation Setup

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 16 of 104

Dipole Measurement Summary

E-Field Scan					
Mode	Frequency (MHz)	Input Power (mW)	Value		Test Date
CW	835	100	Target ¹ Value(V/m)	158.2	/
			Measured ² Value(V/m)	159.0	November 11, 2011
			Deviation ³ (%)	-0.51	/
CW	1880	100	Target ¹ Value(V/m)	140.5	/
			Measured ² Value(V/m)	138.1	Novtember 11, 2011
			Deviation ³ (%)	1.71	/
H-Field Scan					
Mode	Frequency (MHz)	Input Power (mW)	Value		Test Date
CW	835	100	Target ¹ Value(V/m)	0.446	/
			Measured ² Value(V/m)	0.455	Novtember 11, 2011
			Deviation ³ (%)	-2.02	/
CW	1880	100	Target ¹ Value(V/m)	0.468	/
			Measured ² Value(V/m)	0.462	Novtember 11, 2011
			Deviation ³ (%)	1.28	/

Notes: 1. Target value is provided by SPEAD in the calibration certificate of specific dipoles.

2. please refer to the attachment for detailed measurement data and plot.

3. Deviation (%) = 100 * (Target value minus Measured value) divided by Target value.

2.5. Probe Modulation Factor

The Probe Modulation Factor (PMF) is defined as the ratio of the field readings for a CW and a modulated signal with the equivalent Field Envelope Peak as defined in ANSI C63.19 (Chapter C.3.1). Calibration shall be made of the modulation response of the probe and its instrumentation chain. This Calibration shall be performed with the field probe, attached to the instrumentation that is to be used with it during the measurement. The response of the probe system to a CW field at the frequency(s) of interest is compared to its response to a modulated signal with equal peak amplitude. The field level of the test signals shall be more than 10dB above the ambient level and the noise floor of the instrumentation being used. The ratio of the CW reading to that taken with a modulated field shall be applied to the readings taken of modulated fields of the specified type.

Modulation Factor Test Procedure

This may be done using the following procedure:

1. Fix the field probe in a set location relative to a field generating device, such as the reference dipole antenna.
2. Illuminate the probe using the wireless device connected to the reference dipole with a test signal at the intended measurement frequency, Ensure there is sufficient field coupling between the probe and the antenna so the resulting reading is greater than 10 dB above the probe system noise floor but within the systems operating range.
3. Record the amplitude applied to the antenna during transmission and the field strength measured by the E-field probe located near the tip of the dipole antenna
4. Replace the wireless device with an RF signal generator producing an unmodulated CW signal and set to the wireless device operating frequency.
5. Set the amplitude of the unmodulated signal to equal that recorded from the wireless device.
6. Record the reading of the probe measurement system of the unmodulated signal.
7. The ratio, in linear units, of the probe reading in Step 6 to the reading in Step 3 is the E-field modulation factor. $PMF_E = E_{CW} / E_{mod}$ ($PMF_H = H_{CW} / H_{mod}$)
8. Repeat the previous steps using the H-field probe, except locate the probe at the center of the dipole.

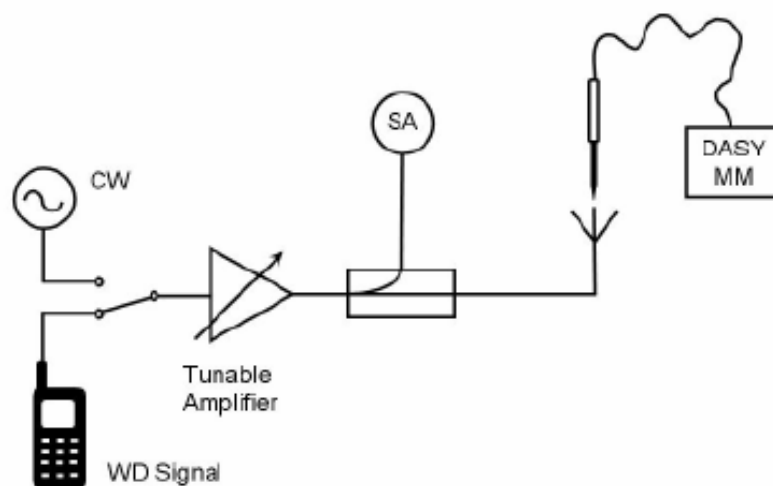


Figure Figure 7 Probe Modulation Factor Test Setup

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 18 of 104

PMF

Band	E-Field Probe Modulation Factor	H-Field Probe Modulation Factor
CDMA Cellular	1.05	1.01
CDMA PCS	1.03	1.00
CDMA AWS	1.03	1.00

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 19 of 104

2.6. Conducted Output Power Measurement

Summary

The DUT is tested using an E5515C communications tester as controller unit to set test channels and maximum output power to the DUT, as well as for measuring the conducted power. Conducted output power was measured using an integrated RF connector and attached RF cable. This result contains conducted output power for the EUT.

Conducted Power Results

CDMA Cellular	Conducted Power (dBm)		
	Channel 1013	Channel 384	Channel 777
RC3	24.32	24.1	23.94
RC1	24.49	24.22	24.02
CDMA PCS	Conducted Power (dBm)		
	Channel 25	Channel 600	Channel 1175
RC3	23.89	23.91	23.75
RC1	23.91	23.96	23.82
CDMA AWS	Conducted Power (dBm)		
	Channel 25	Channel 450	Channel 850
RC3	23.51	23.75	23.67
RC1	23.63	23.73	23.66

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 20 of 104

3. Test Results

3.1. ANSI C63.19-2007 Limits

Category		Telephone RF parameters < 960 MHz			
Near field	AWF	E-field emissions		H-field emissions	
Category M1/T1	0	631.0 to 1122.0	V/m	1.91 to 3.39	A/m
	-5	473.2 to 841.4	V/m	1.43 to 2.54	A/m
Category M2/T2	0	354.8 to 631.0	V/m	1.07 to 1.91	A/m
	-5	266.1 to 473.2	V/m	0.80 to 1.43	A/m
Category M3/T3	0	199.5 to 354.8	V/m	0.60 to 1.07	A/m
	-5	149.6 to 266.1	V/m	0.45 to 0.80	A/m
Category M4/T4	0	< 199.5	V/m	< 0.60	A/m
	-5	< 149.6	V/m	< 0.45	A/m
Category		Telephone RF parameters > 960 MHz			
Near field	AWF	E-field emissions		H-field emissions	
Category M1/T1	0	199.5 to 354.8	V/m	0.60 to 1.07	A/m
	-5	149.6 to 266.1	V/m	0.45 to 0.80	A/m
Category M2/T2	0	112.2 to 199.5	V/m	0.34 to 0.60	A/m
	-5	84.1 to 149.6	V/m	0.25 to 0.45	A/m
Category M3/T3	0	63.1 to 112.2	V/m	0.19 to 0.34	A/m
	-5	47.3 to 84.1	V/m	0.14 to 0.25	A/m
Category M4/T4	0	< 63.1	V/m	< 0.19	A/m
	-5	< 47.3	V/m	< 0.14	A/m

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 21 of 104

3.2. Summary Test Results

CDMA Cellular Results

E-Field					
Channel	Frequency (MHz)	Peak Field (V/m)	Power Drift (dB)	Rating	Graph Results
777	848.31	83.0	-0.014	M4	Figure 12
384	836.52	77.4	-0.005	M4	Figure 13
1013	824.70	56.4	-0.030	M4	Figure 14
H-Field					
Channel	Frequency (MHz)	Peak Field (A/m)	Power Drift (dB)	Rating	Graph Results
777	848.31	0.109	-0.079	M4	Figure 15
384	836.52	0.110	-0.064	M4	Figure 16
1013	824.70	0.095	-0.027	M4	Figure 17

CDMA PCS Results

E-Field					
Channel	Frequency (MHz)	Peak Field (V/m)	Power Drift (dB)	Rating	Graph Results
1175	1908.75	32.0	-0.023	M4	Figure 18
600	1880	29.4	-0.096	M4	Figure 19
25	1851.25	26.5	-0.144	M4	Figure 20
H-Field					
Channel	Frequency (MHz)	Peak Field (A/m)	Power Drift (dB)	Rating	Graph Results
1175	1908.75	0.075	-0.077	M4	Figure 21
600	1880	0.074	-0.144	M4	Figure 22
25	1851.25	0.062	0.021	M4	Figure 23

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 22 of 104

CDMA AWS Results

E-Field					
Channel	Frequency (MHz)	Peak Field (V/m)	Power Drift (dB)	Rating	Graph Results
850	1752.5	28.7	0.151	M4	Figure 24
450	1732.5	26.8	0.027	M4	Figure 25
25	1711.25	30.0	0.048	M4	Figure 26
H-Field					
Channel	Frequency (MHz)	Peak Field (A/m)	Power Drift (dB)	Rating	Graph Results
850	1752.5	0.073	0.043	M4	Figure 27
450	1732.5	0.067	0.090	M4	Figure 28
25	1711.25	0.071	-0.052	M4	Figure 29

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 23 of 104

4. Measurement Uncertainty

No.	Error source	Type	Uncertainty Value (%)	Prob. Dist.	k	c_{iE}	c_{iH}	Standard Uncertainty (%) u_i (%) E	Standard Uncertainty (%) u_i (%) H	Degree of freedom V_{eff} or v_i
Measurement System										
1	Probe Calibration	B	5.1	N	1	1	1	5.1	5.1	∞
2	Axial Isotropy	B	4.7	R	$\sqrt{3}$	1	1	2.7	2.7	∞
3	Sensor Displacement	B	16.5	R	$\sqrt{3}$	1	0.145	9.5	1.4	∞
4	Boundary Effects	B	2.4	R	$\sqrt{3}$	1	1	1.4	1.4	∞
5	Linearity	B	4.7	R	$\sqrt{3}$	1	1	2.7	2.7	∞
6	Scaling to Peak Envelope Power	B	2.0	R	$\sqrt{3}$	1	1	1.2	1.2	∞
7	System Detection Limit	B	1.0	R	$\sqrt{3}$	1	1	0.6	0.6	∞
8	Readout Electronics	B	0.3	N	1	1	1	0.3	0.3	∞
9	Response Time	B	0.8	R	$\sqrt{3}$	1	1	0.5	0.5	∞
10	Integration Time	B	2.6	R	$\sqrt{3}$	1	1	1.5	1.5	∞
11	RF Ambient Conditions	B	3.0	R	$\sqrt{3}$	1	1	1.7	1.7	∞
12	RF Reflections	B	12.0	R	$\sqrt{3}$	1	1	6.9	6.9	∞
13	Probe Positioner	B	1.2	R	$\sqrt{3}$	1	0.67	0.7	0.5	∞
14	Probe Positioning	A	4.7	R	$\sqrt{3}$	1	0.67	2.7	1.8	∞
15	Extra. And Interpolation	B	1.0	R	$\sqrt{3}$	1	1	0.6	0.6	∞
Test Sample Related										
16	Device Positioning Vertical	B	4.7	R	$\sqrt{3}$	1	0.67	2.7	1.8	∞
17	Device Positioning Lateral	B	1.0	R	$\sqrt{3}$	1	1	0.6	0.6	∞
18	Device Holder and Phantom	B	2.4	R	$\sqrt{3}$	1	1	1.4	1.4	∞

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 24 of 104

19	Power Drift	B	5.0	R	$\sqrt{3}$	1	1	2.9	2.9	∞
Phantom and Setup related										
20s	Phantom Thickness	B	2.4	R	$\sqrt{3}$	1	0.67	1.4	0.9	∞
Combined standard uncertainty(%)								14.7	10.9	
Expanded Std. uncertainty on power (K=2)								29.4	21.8	
Expanded Std. uncertainty on field (K=2)								14.7	10.9	

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 25 of 104

5. Main Test Instruments

No.	Name	Type	Serial Number	Calibration Date	Valid Period
01	Power meter	Agilent E4417A	GB41291714	March 12, 2011	One year
02	Power sensor	Agilent N8481H	MY50350004	September 25, 2011	One year
03	Signal Generator	HP 8341B	2730A00804	September 12, 2011	One year
04	Amplifier	IXA-020	0401	No Calibration Requested	
05	BTS	E5515C	MY48360988	December 3, 2010	One year
06	E-Field Probe	ER3DV6	2302	June 15, 2011	One year
07	H-Field Probe	H3DV6	6187	June 17, 2011	One year
08	DAE	DAE4	871	November 18, 2010	One year
09	Validation Kit 835MHz	CD835V3	1133	April 22, 2009	Three years
10	Validation Kit 1880MHz	CD1880V3	1115	April 22, 2009	Three years

*****END OF REPORT BODY*****

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 26 of 104

ANNEX A: System Check Results

HAC_System Performance Check at 835MHz_E

DUT: Dipole 835 MHz; Type: CD835V3; SN: 1133

Date/Time: 11/11/2011 10:45:32 AM

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2302; ConvF(1, 1, 1); Calibrated: 06/15/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

E Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 159.0 V/m

Probe Modulation Factor = 1.00

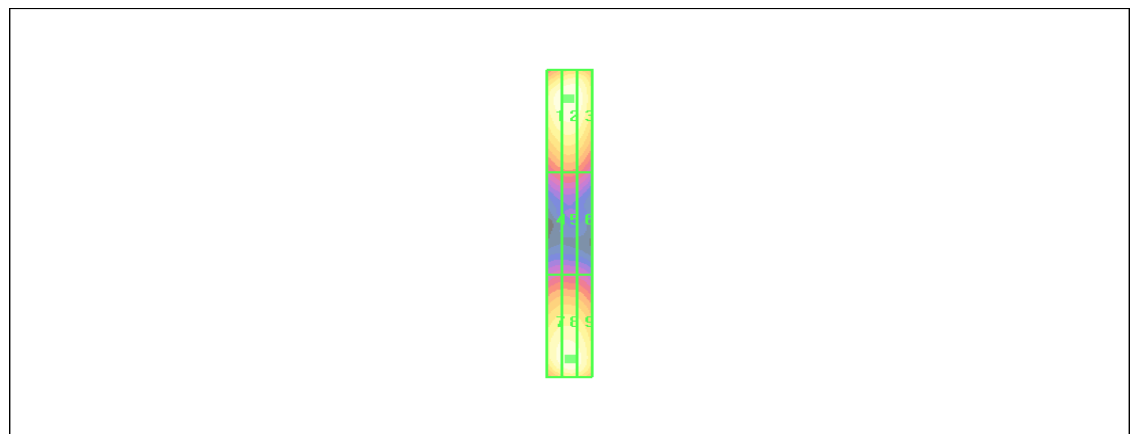
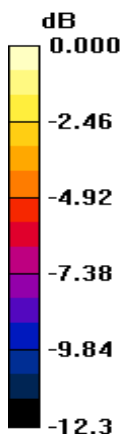
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 105.5 V/m; Power Drift = -0.026 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1 158.1 M4	Grid 2 161.0 M4	Grid 3 156.3 M4
Grid 4 86.9 M4	Grid 5 89.2 M4	Grid 6 85.8 M4
Grid 7 155.0 M4	Grid 8 159.0 M4	Grid 9 154.2 M4



0 dB = 161.0V/m

Figure 8 System Performance Check 835MHz_E

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 27 of 104

HAC_System Performance Check at 835MHz_H

DUT: Dipole 835 MHz; Type: CD835V3; SN: 1133

Date/Time: 11/11/2011 8:00:58 AM

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6187 ; Calibrated: 06/17/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

H Scan - measurement distance from the probe sensor center to CD835 Dipole =

10mm/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.455 A/m

Probe Modulation Factor = 1.00

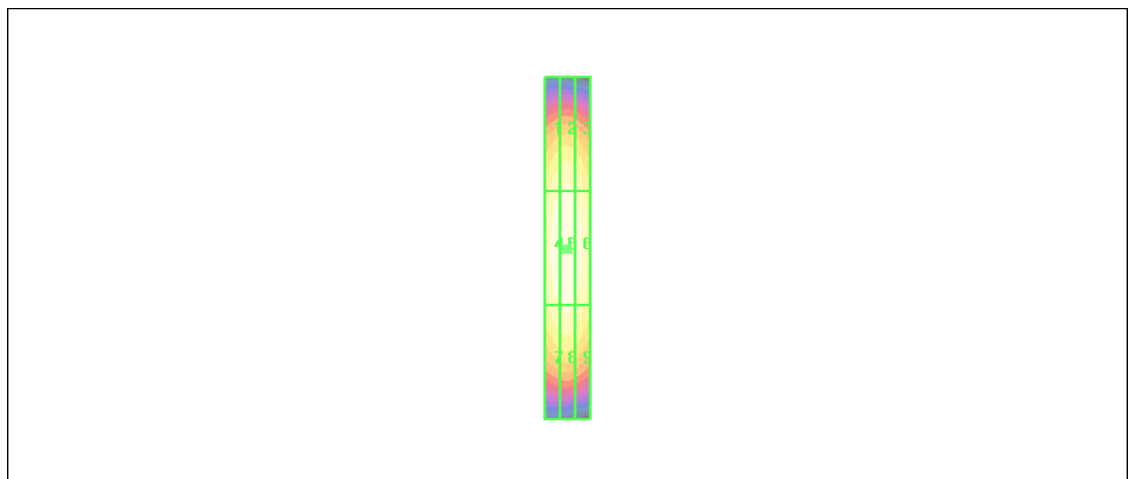
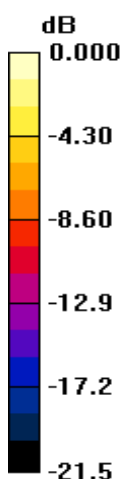
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.485 A/m; Power Drift = -0.005 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.383 M4	Grid 2 0.401 M4	Grid 3 0.376 M4
Grid 4 0.437 M4	Grid 5 0.455 M4	Grid 6 0.429 M4
Grid 7 0.386 M4	Grid 8 0.401 M4	Grid 9 0.377 M4



0 dB = 0.455A/m

Figure 9 System Performance Check 835MHz_H

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 28 of 104

HAC_System Performance Check at 1880MHz_E

DUT: Dipole 1880 MHz; Type: CD1880V3; SN: 1115

Date/Time: 11/11/2011 9:20:34 AM

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2302; ConvF(1, 1, 1); Calibrated: 06/15/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

E Scan - measurement distance from the probe sensor center to CD1880 Dipole =

10mm/Hearing Aid Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 138.1 V/m

Probe Modulation Factor = 1.00

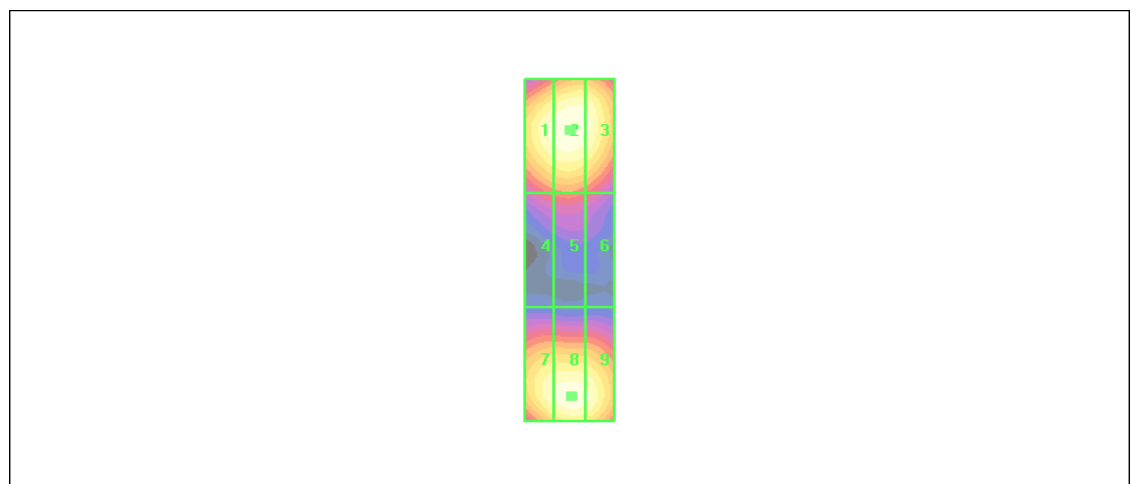
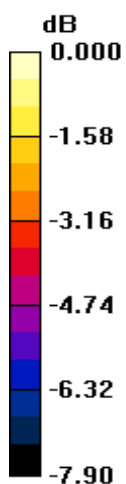
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 156.5 V/m; Power Drift = -0.007 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak E-field in V/m

Grid 1 134.9 M2	Grid 2 139.3 M2	Grid 3 135.0 M2
Grid 4 93.7 M3	Grid 5 96.0 M3	Grid 6 91.5 M3
Grid 7 132.3 M2	Grid 8 138.1 M2	Grid 9 134.6 M2



0 dB = 139.3V/m

Figure 10 System Performance Check 1880MHz_E

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 29 of 104

HAC_System Performance Check at 1880MHz_H

DUT: Dipole 1880 MHz; Type: CD1880V3; SN:1115

Date/Time: 11/11/2011 6:30:22 AM

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6187 ; Calibrated: 06/17/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

H Scan - measurement distance from the probe sensor center to Dipole = 10mm/Hearing Aid

Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.462 A/m

Probe Modulation Factor = 1.00

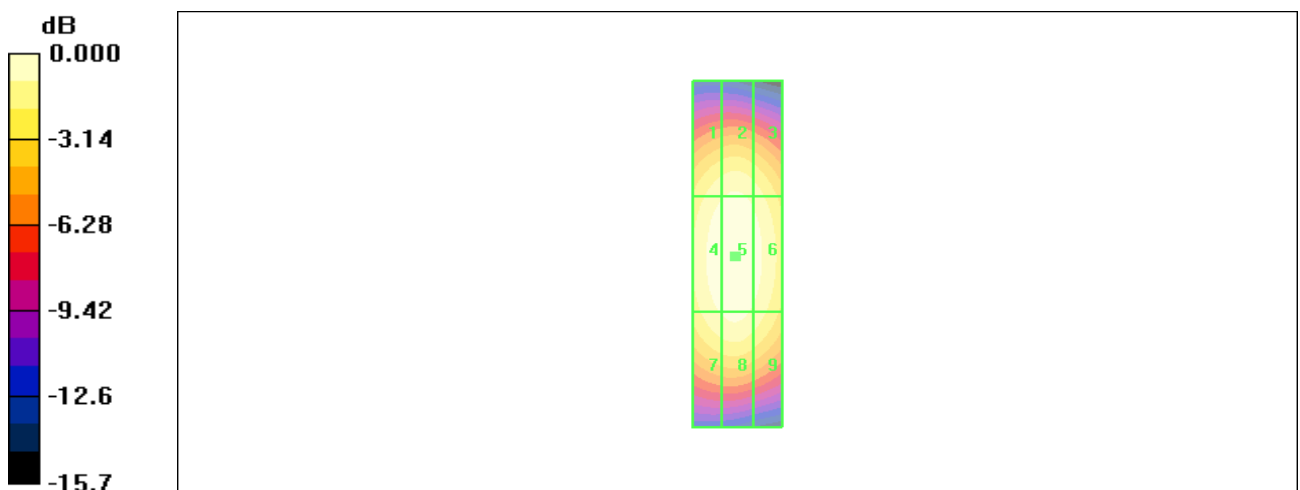
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.489 A/m; Power Drift = 0.040 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.405 M2	Grid 2 0.419 M2	Grid 3 0.394 M2
Grid 4 0.448 M2	Grid 5 0.462 M2	Grid 6 0.435 M2
Grid 7 0.414 M2	Grid 8 0.427 M2	Grid 9 0.400 M2



0 dB = 0.462A/m

Figure 11 System Performance Check 1880MHz_H

ANNEX B: Graph Results

HAC RF E-Field CDMA Cellular High

Date/Time: 11/11/2011 12:11:38 PM

Communication System: CDMA ; Frequency: 848.31 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2302; ConvF(1, 1, 1); Calibrated: 06/15/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

M920 CDMA Cellular HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 83 V/m

Probe Modulation Factor = 1.05

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 106.3 V/m; Power Drift = -0.014 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
81.2 M4	83.1 M4	77.3 M4
Grid 4	Grid 5	Grid 6
79.4 M4	83 M4	77.4 M4
Grid 7	Grid 8	Grid 9
73.3 M4	77.4 M4	72.4 M4

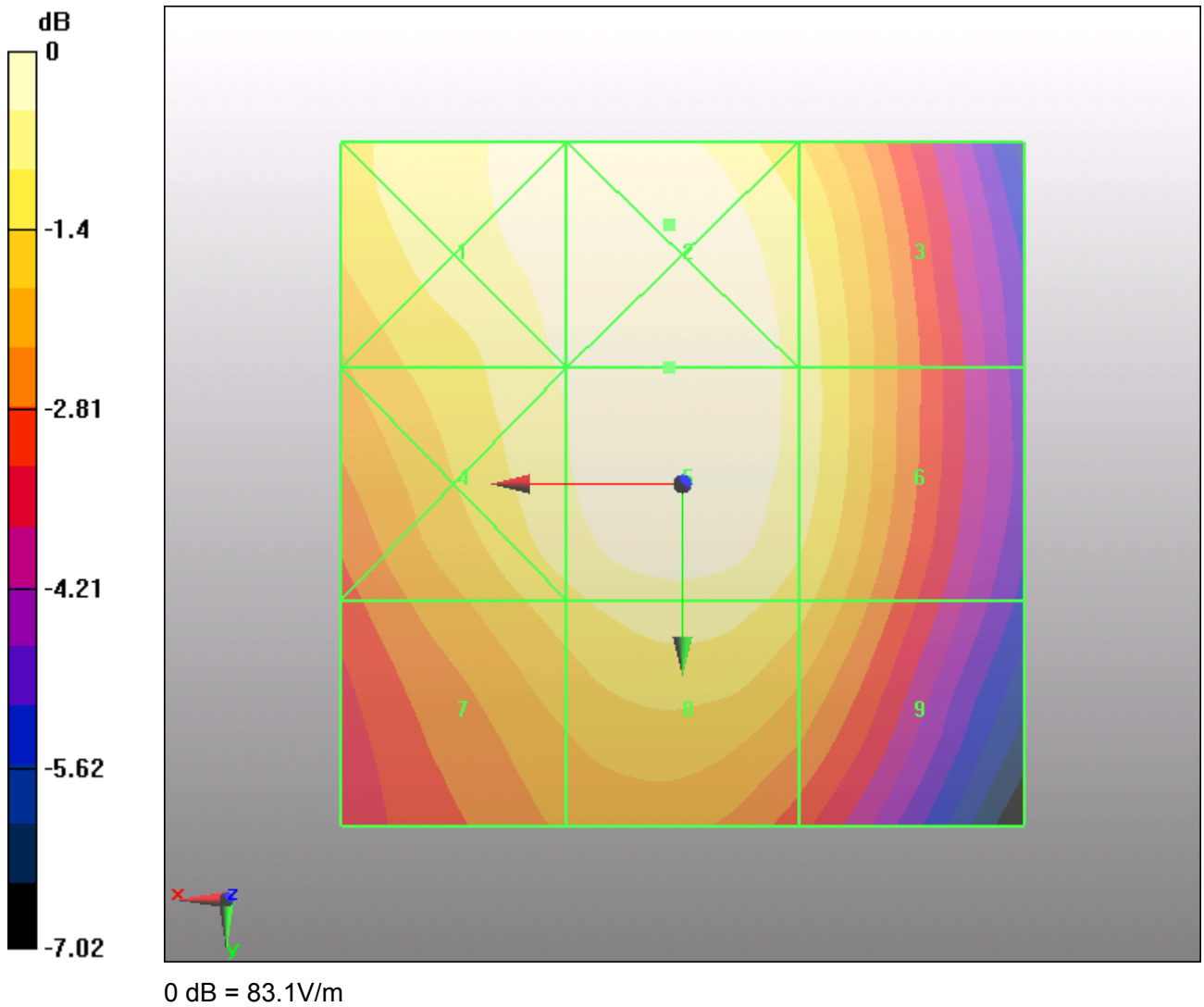


Figure 12 HAC RF E-Field CDMA Cellular Channel 777

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 32 of 104

HAC RF E-Field CDMA Cellular Middle

Date/Time: 11/11/2011 12:05:34 PM

Communication System: CDMA ; Frequency: 836.52 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2302; ConvF(1, 1, 1); Calibrated: 06/15/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

M920 CDMA Cellular HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 77.4 V/m

Probe Modulation Factor = 1.05

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 98.7 V/m; Power Drift = -0.005 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1 76.9 M4	Grid 2 78.2 M4	Grid 3 71 M4
Grid 4 75.5 M4	Grid 5 77.4 M4	Grid 6 71.1 M4
Grid 7 69.3 M4	Grid 8 71.7 M4	Grid 9 65.8 M4

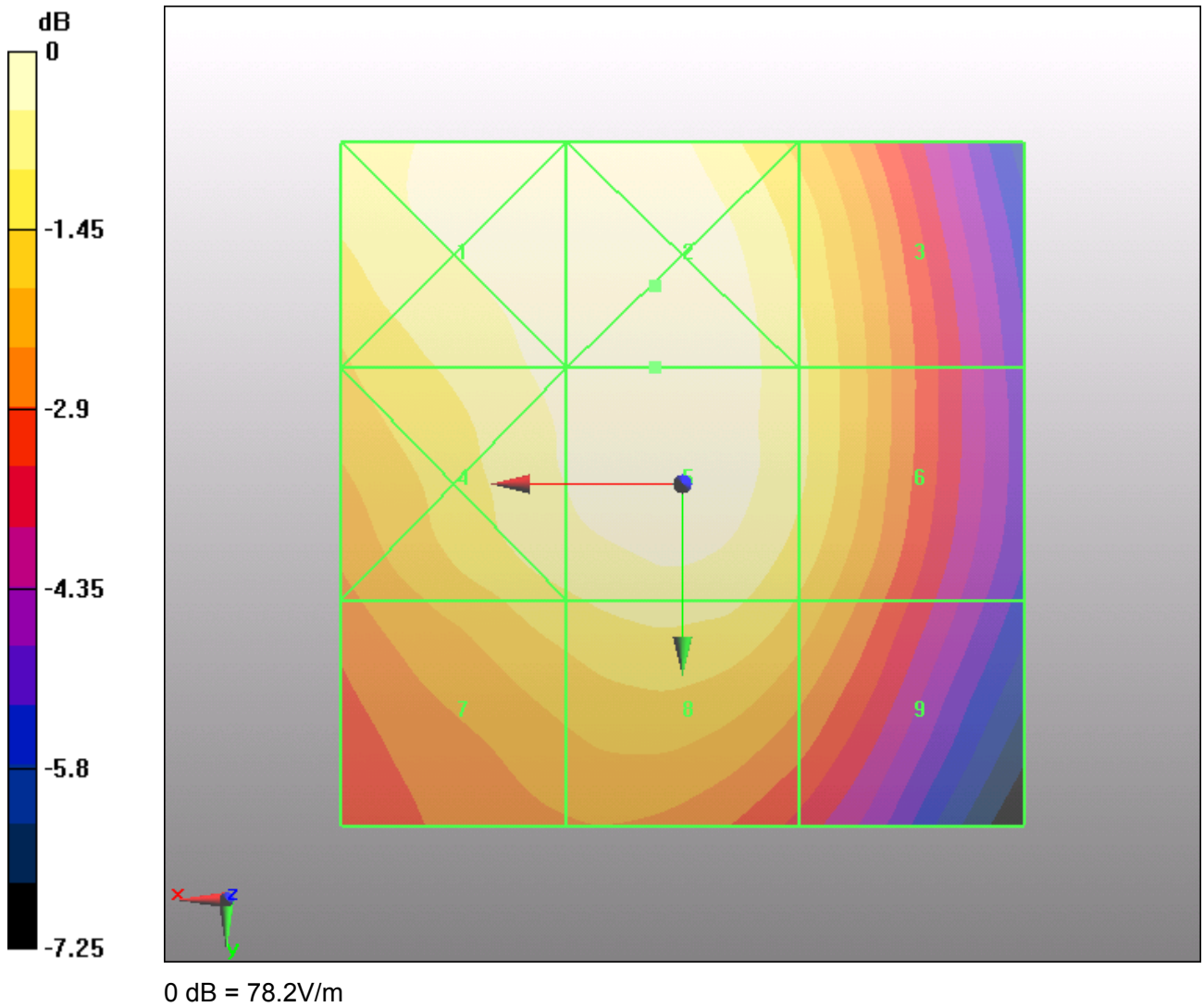


Figure 13 HAC RF E-Field CDMA Cellular Channel 384

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 34 of 104

HAC RF E-Field CDMA Cellular Low

Date/Time: 11/11/2011 12:17:06 PM

Communication System: CDMA ; Frequency: 824.7 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2302; ConvF(1, 1, 1); Calibrated: 06/15/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

M920 CDMA Cellular HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 56.4 V/m

Probe Modulation Factor = 1.05

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 70.8 V/m; Power Drift = -0.030 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
54.5 M4	56.1 M4	52.8 M4
Grid 4	Grid 5	Grid 6
53.9 M4	56.4 M4	53.9 M4
Grid 7	Grid 8	Grid 9
51.5 M4	54.5 M4	52.7 M4

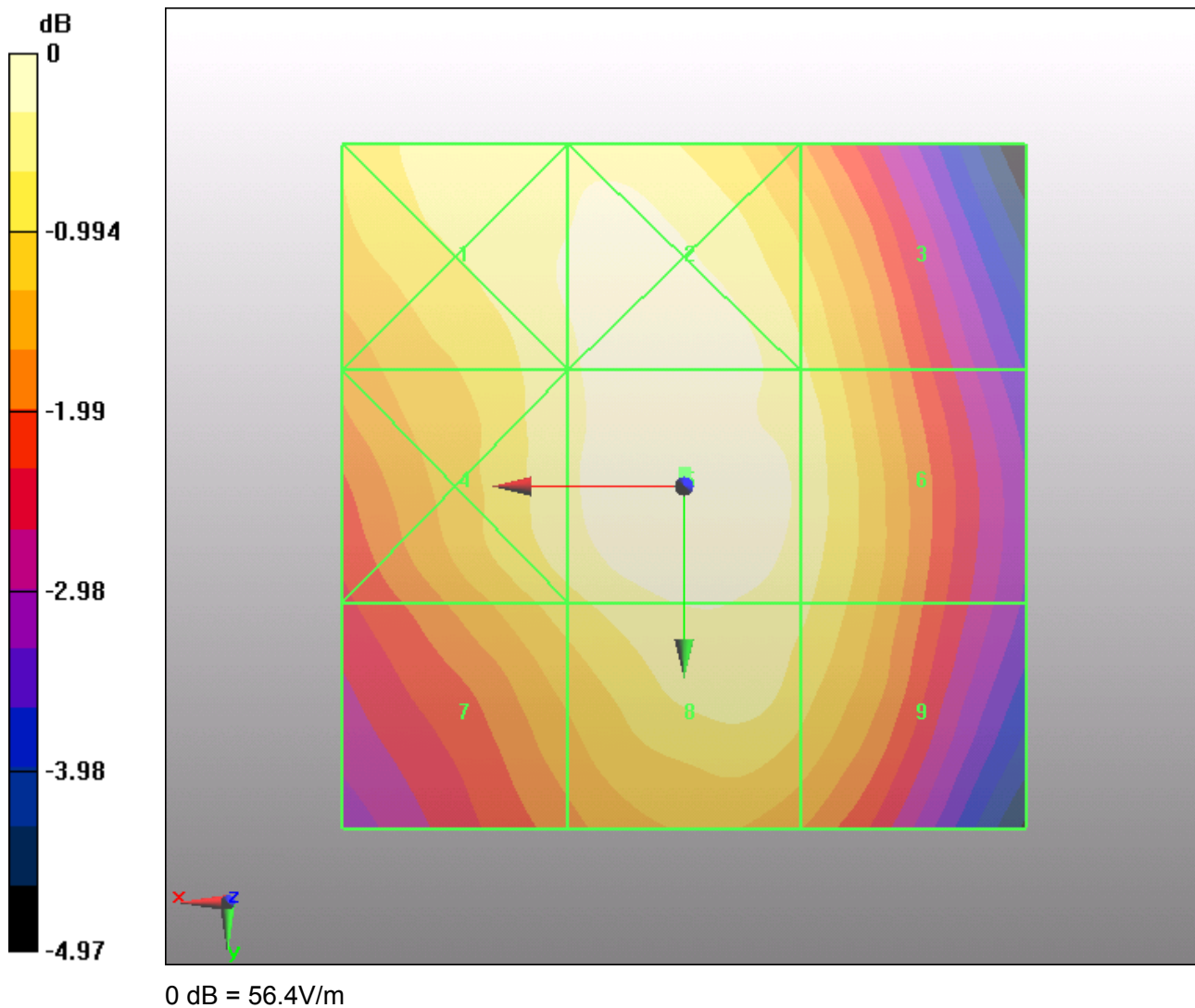


Figure 14 HAC RF E-Field CDMA Cellular Channel 1013

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 36 of 104

HAC RF H-Field CDMA Cellular High

Date/Time: 11/11/2011 1:42:24 PM

Communication System: CDMA ; Frequency: 848.31 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6187 ; Calibrated: 06/17/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

M920 CDMA Cellular HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.109 A/m

Probe Modulation Factor = 1.01

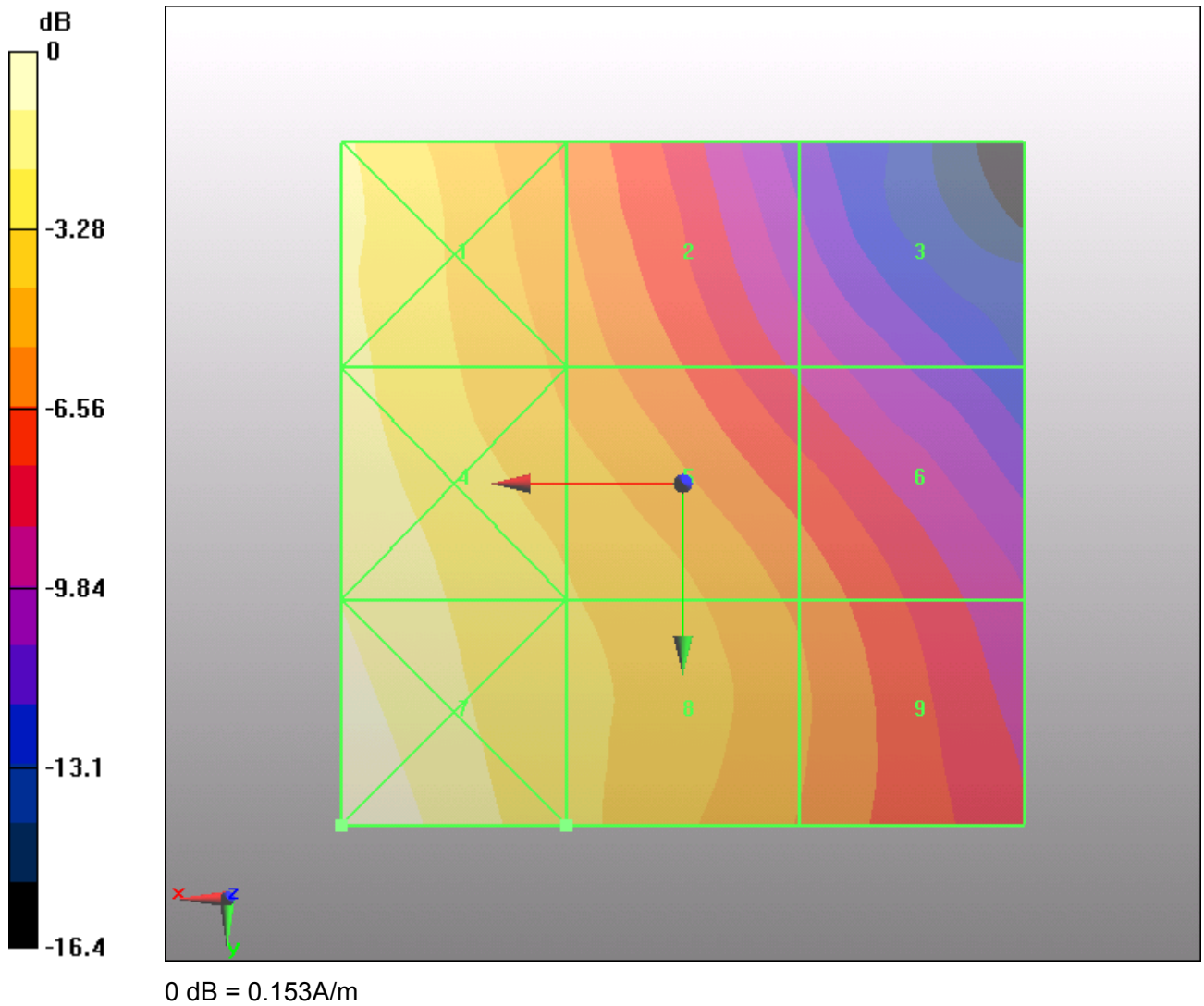
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.092 A/m; Power Drift = -0.079 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.124 M4	Grid 2 0.090 M4	Grid 3 0.055 M4
Grid 4 0.134 M4	Grid 5 0.106 M4	Grid 6 0.079 M4
Grid 7 0.153 M4	Grid 8 0.109 M4	Grid 9 0.084 M4



TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 38 of 104

HAC RF H-Field CDMA Cellular Middle

Date/Time: 11/11/2011 1:36:47 PM

Communication System: CDMA ; Frequency: 836.52 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6187 ; Calibrated: 06/17/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

M920 CDMA Cellular HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.110 A/m

Probe Modulation Factor = 1.01

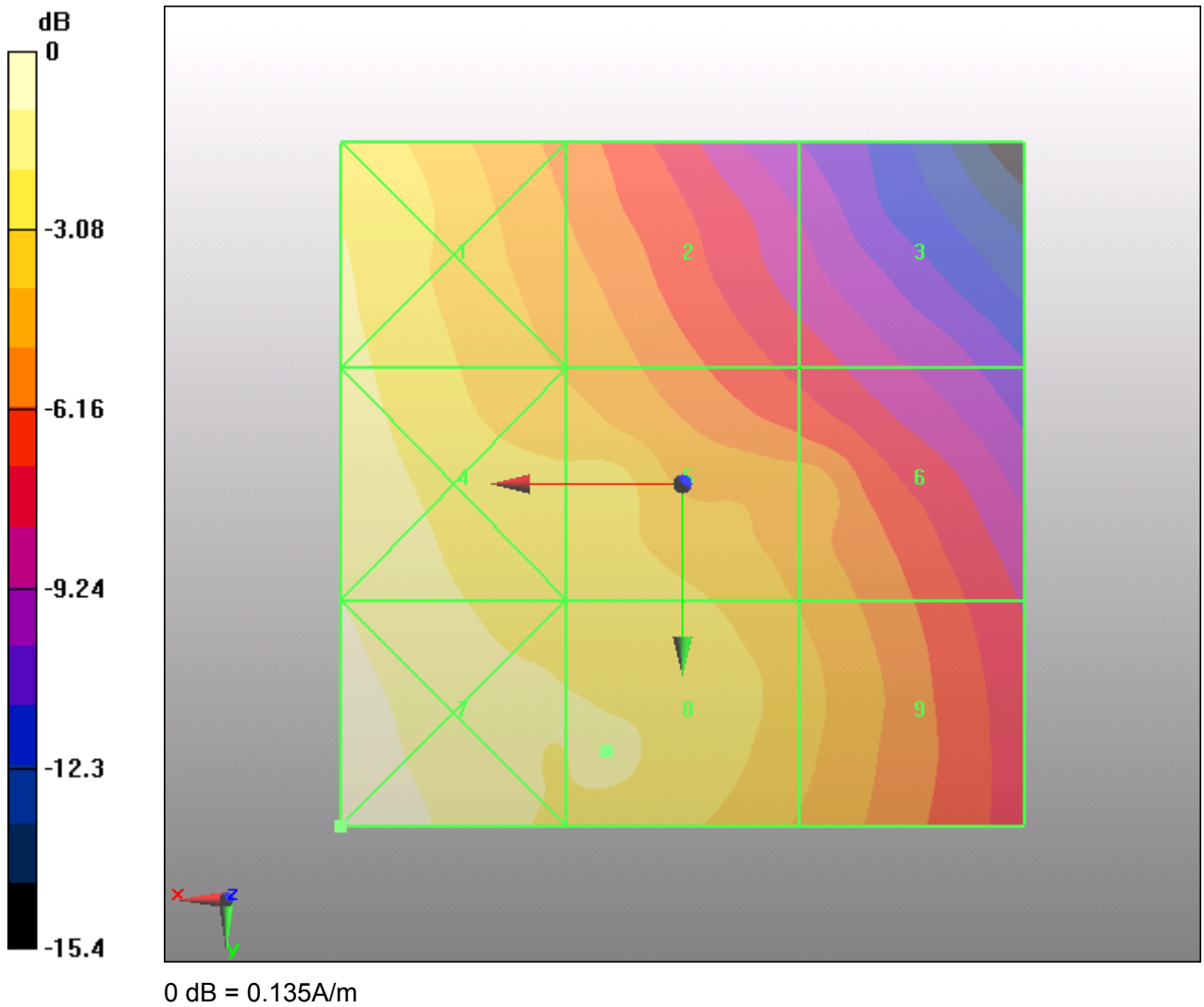
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.096 A/m; Power Drift = -0.064 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.110 M4	Grid 2 0.083 M4	Grid 3 0.057 M4
Grid 4 0.120 M4	Grid 5 0.103 M4	Grid 6 0.084 M4
Grid 7 0.135 M4	Grid 8 0.110 M4	Grid 9 0.089 M4



TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 40 of 104

HAC RF H-Field CDMA Cellular Low

Date/Time: 11/11/2011 1:47:45 PM

Communication System: CDMA ; Frequency: 824.7 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6187 ; Calibrated: 06/17/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

M920 CDMA Cellular HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.095 A/m

Probe Modulation Factor = 1.01

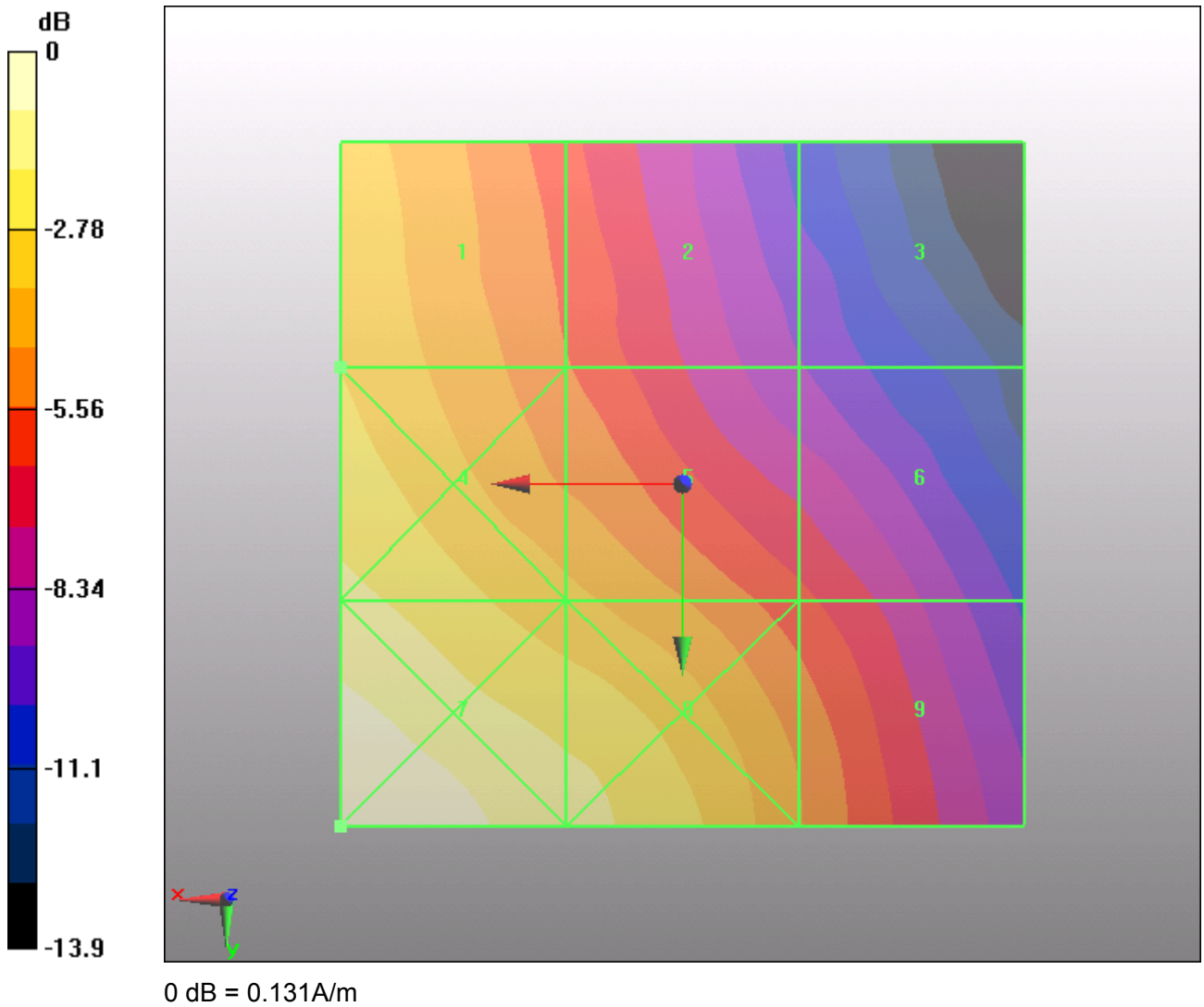
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.068 A/m; Power Drift = -0.027 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.095 M4	0.070 M4	0.046 M4
Grid 4	Grid 5	Grid 6
0.109 M4	0.088 M4	0.064 M4
Grid 7	Grid 8	Grid 9
0.131 M4	0.110 M4	0.078 M4



TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 42 of 104

HAC RF E-Field CDMA PCS High

Date/Time: 11/11/2011 12:29:30 PM

Communication System: CDMA ; Frequency: 1908.75 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2302; ConvF(1, 1, 1); Calibrated: 06/15/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

M920 CDMA PCS HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 32 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 33 V/m; Power Drift = -0.023 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
27.4 M4	33.8 M4	33.5 M4
Grid 4	Grid 5	Grid 6
23.4 M4	32 M4	31.9 M4
Grid 7	Grid 8	Grid 9
30.7 M4	25.1 M4	24.6 M4

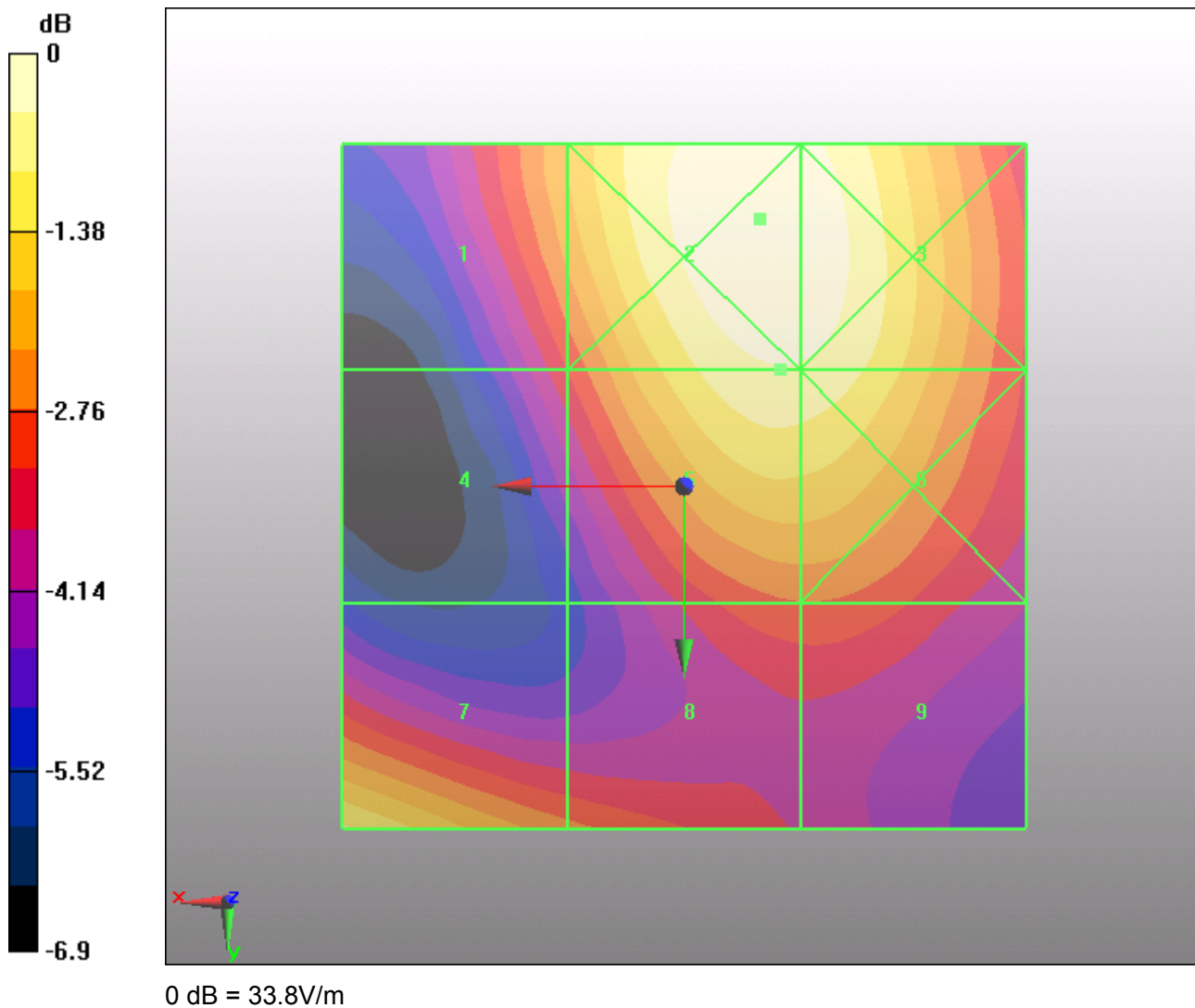


Figure 18 HAC RF E-Field CDMA PCS Channel 1175

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 44 of 104

HAC RF E-Field CDMA PCS Middle

Date/Time: 11/11/2011 12:24:05 PM

Communication System: CDMA ; Frequency: 1880 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2302; ConvF(1, 1, 1); Calibrated: 06/15/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

M920 CDMA PCS HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 29.4 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 30.6 V/m; Power Drift = -0.096 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1 24.4 M4	Grid 2 30.2 M4	Grid 3 30 M4
Grid 4 21.1 M4	Grid 5 28.9 M4	Grid 6 28.8 M4
Grid 7 29.4 M4	Grid 8 23.3 M4	Grid 9 23 M4

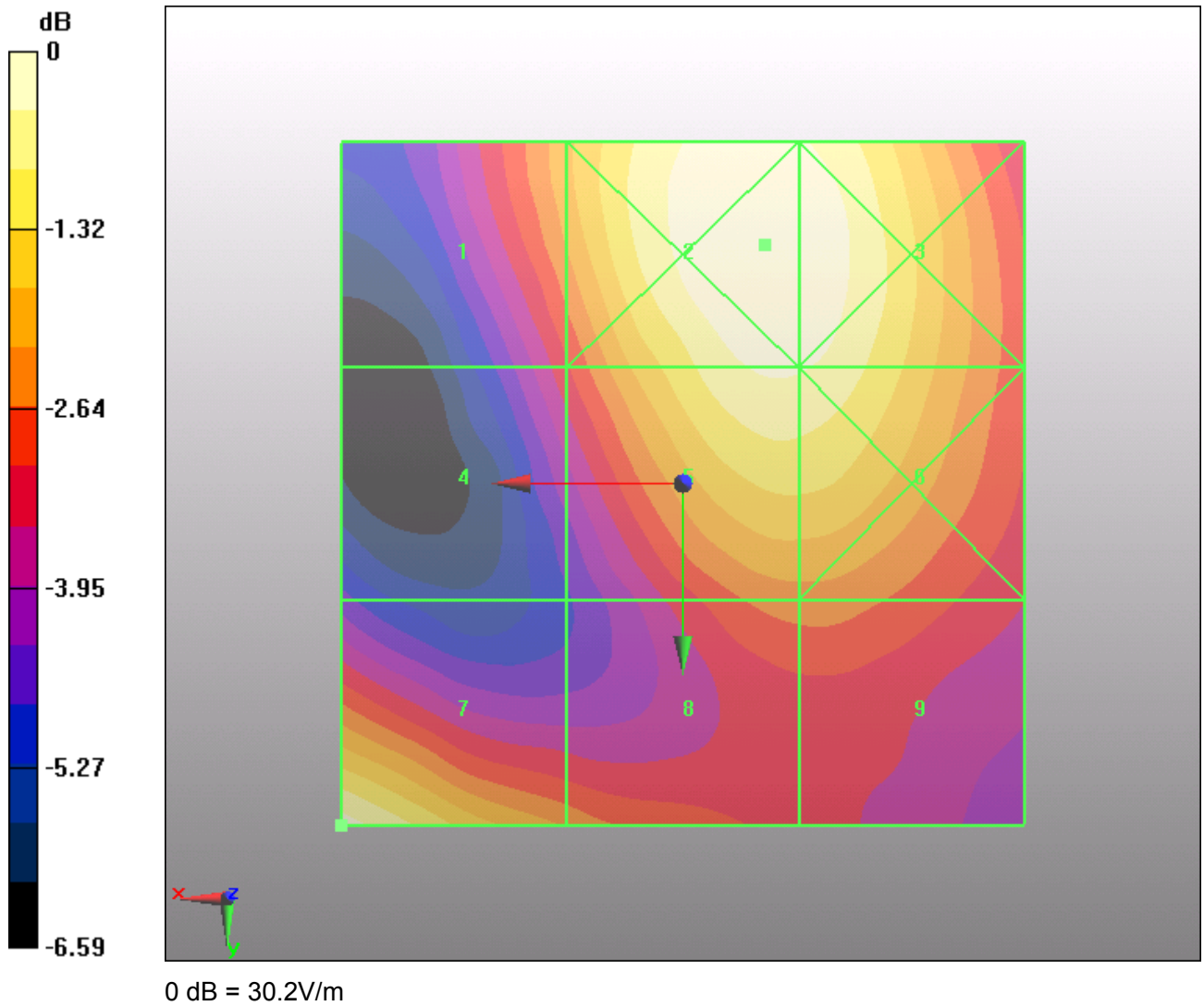


Figure 19 HAC RF E-Field CDMA PCS Channel 600

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 46 of 104

HAC RF E-Field CDMA PCS Low

Date/Time: 11/11/2011 12:35:00 PM

Communication System: CDMA ; Frequency: 1851.25 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2302; ConvF(1, 1, 1); Calibrated: 06/15/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

M920 CDMA PCS HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 26.5 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 25.8 V/m; Power Drift = -0.144 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
21.5 M4	26.5 M4	26.3 M4
Grid 4	Grid 5	Grid 6
18.2 M4	24.9 M4	24.8 M4
Grid 7	Grid 8	Grid 9
27.6 M4	22.8 M4	20.1 M4

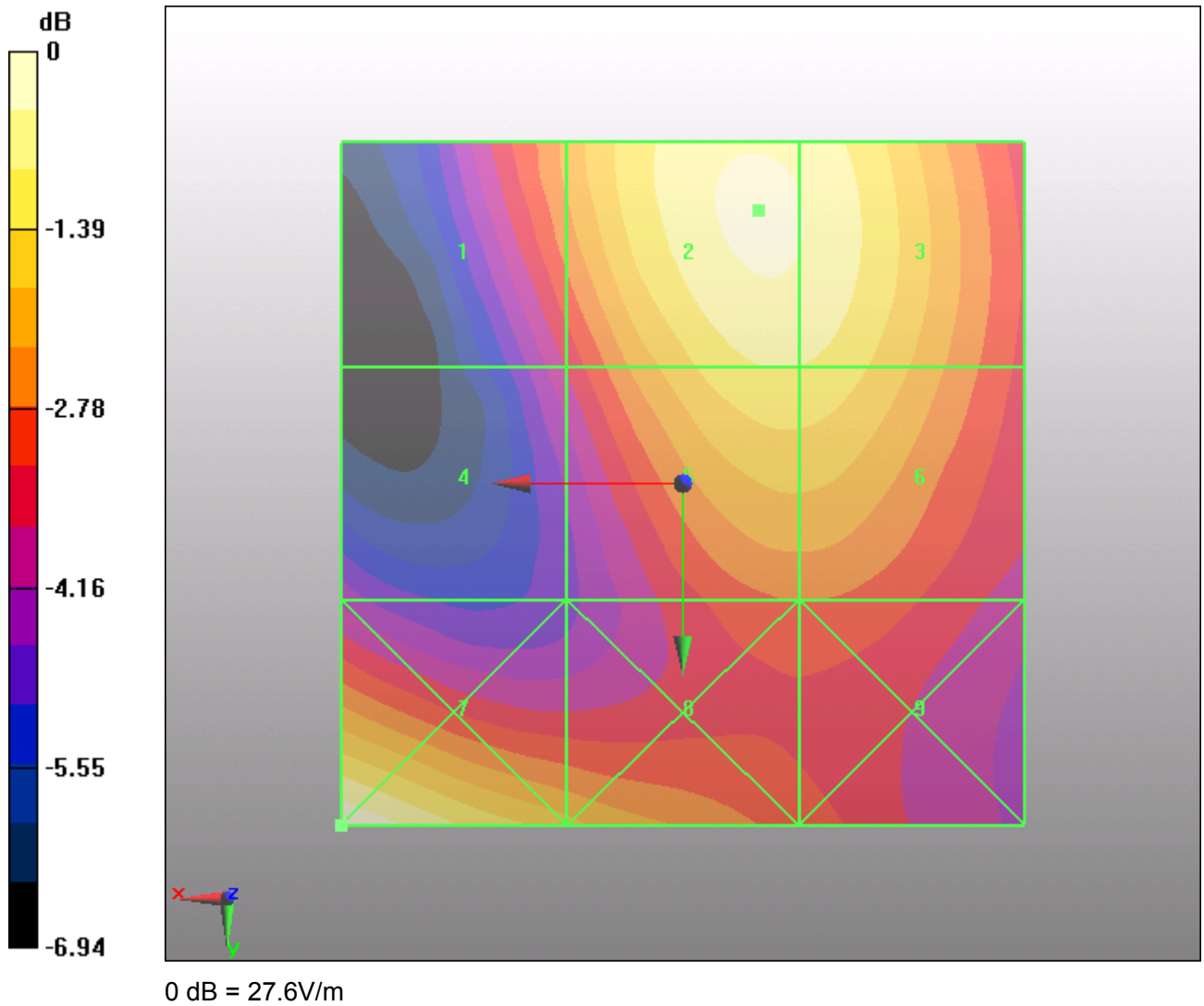


Figure 20 HAC RF E-Field CDMA PCS Channel 25

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 48 of 104

HAC RF H-Field CDMA PCS High

Date/Time: 11/11/2011 1:59:54 PM

Communication System: CDMA ; Frequency: 1908.75 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6187 ; Calibrated: 06/17/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

M920 CDMA PCS HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.075 A/m

Probe Modulation Factor = 1

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.074 A/m; Power Drift = -0.077 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.081 M4	Grid 2 0.070 M4	Grid 3 0.052 M4
Grid 4 0.070 M4	Grid 5 0.071 M4	Grid 6 0.066 M4
Grid 7 0.075 M4	Grid 8 0.075 M4	Grid 9 0.068 M4

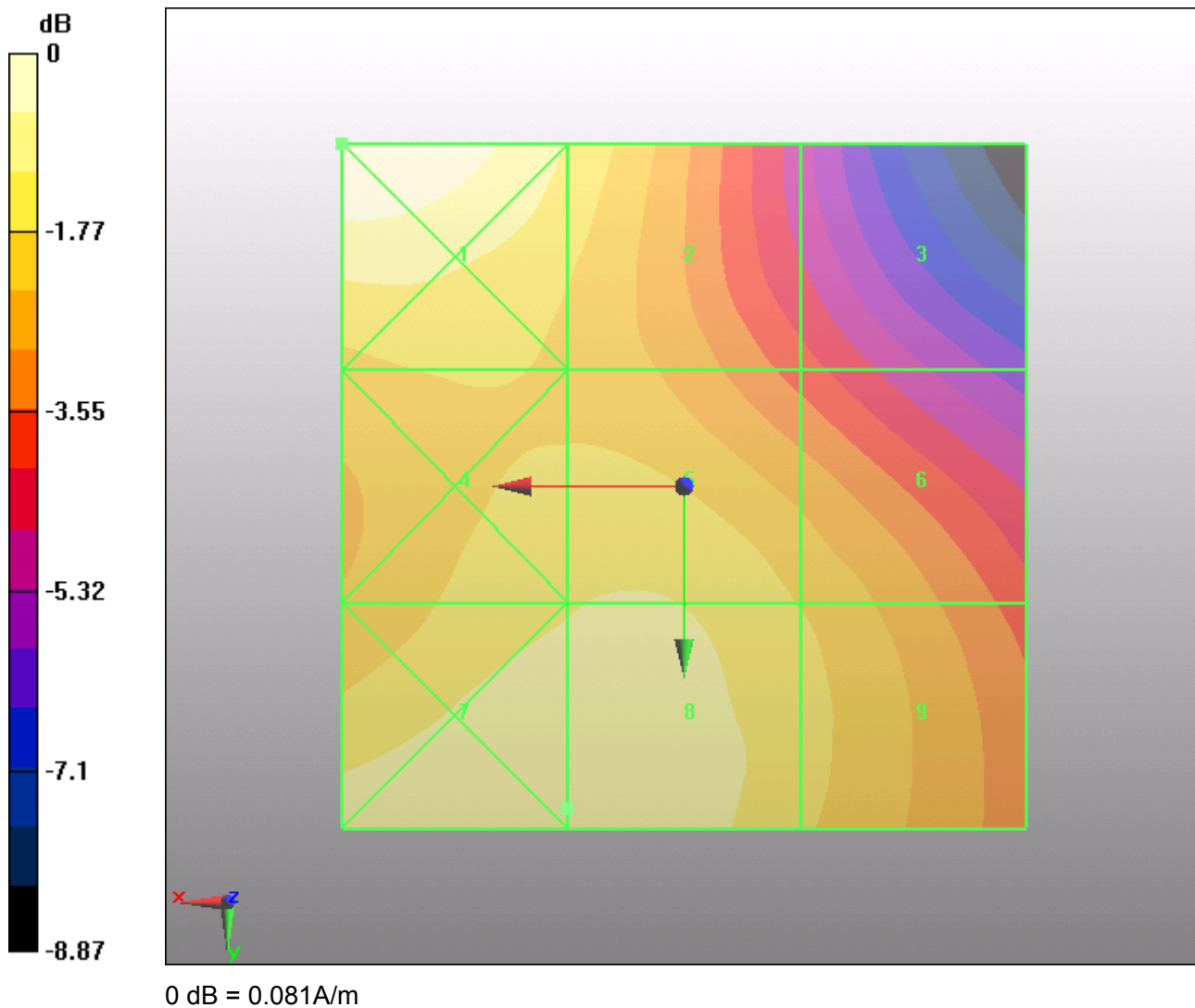


Figure 21 HAC RF H-Field CDMA PCS Channel 1175

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 50 of 104

HAC RF H-Field CDMA PCS Middle

Date/Time: 11/11/2011 1:54:28 PM

Communication System: CDMA ; Frequency: 1880 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6187 ; Calibrated: 06/17/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

M920 CDMA PCS HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.074 A/m

Probe Modulation Factor = 1

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.074 A/m; Power Drift = -0.144 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.074 M4	Grid 2 0.066 M4	Grid 3 0.052 M4
Grid 4 0.070 M4	Grid 5 0.070 M4	Grid 6 0.063 M4
Grid 7 0.074 M4	Grid 8 0.074 M4	Grid 9 0.066 M4

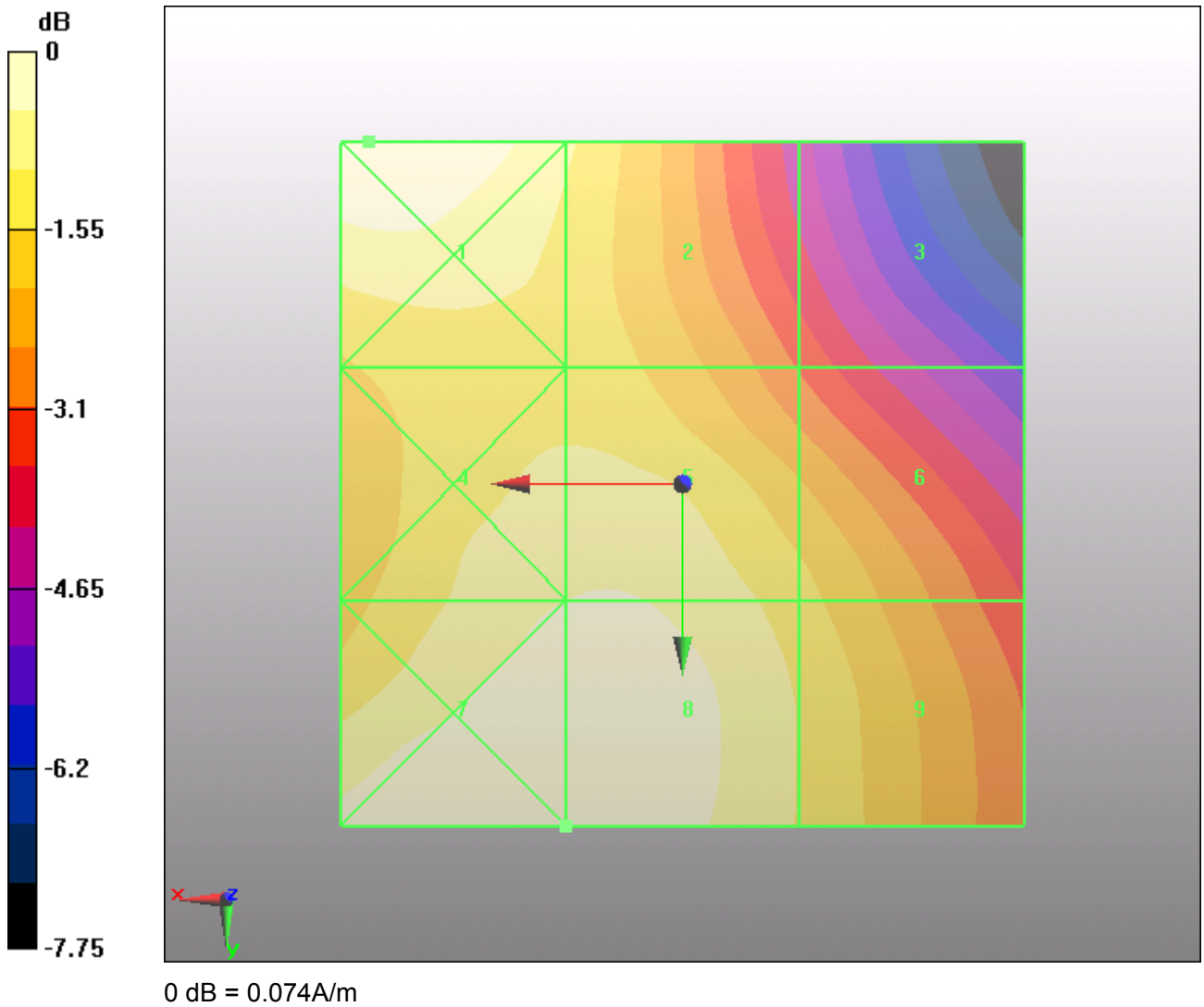


Figure 22 HAC RF H-Field CDMA PCS Channel 600

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 52 of 104

HAC RF H-Field CDMA PCS Low

Date/Time: 11/11/2011 2:05:52 PM

Communication System: CDMA ; Frequency: 1851.25 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6187 ; Calibrated: 06/17/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

M920 CDMA PCS HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.062 A/m

Probe Modulation Factor = 1

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.064 A/m; Power Drift = 0.021 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.062 M4	0.056 M4	0.047 M4
Grid 4	Grid 5	Grid 6
0.061 M4	0.061 M4	0.056 M4
Grid 7	Grid 8	Grid 9
0.065 M4	0.063 M4	0.056 M4

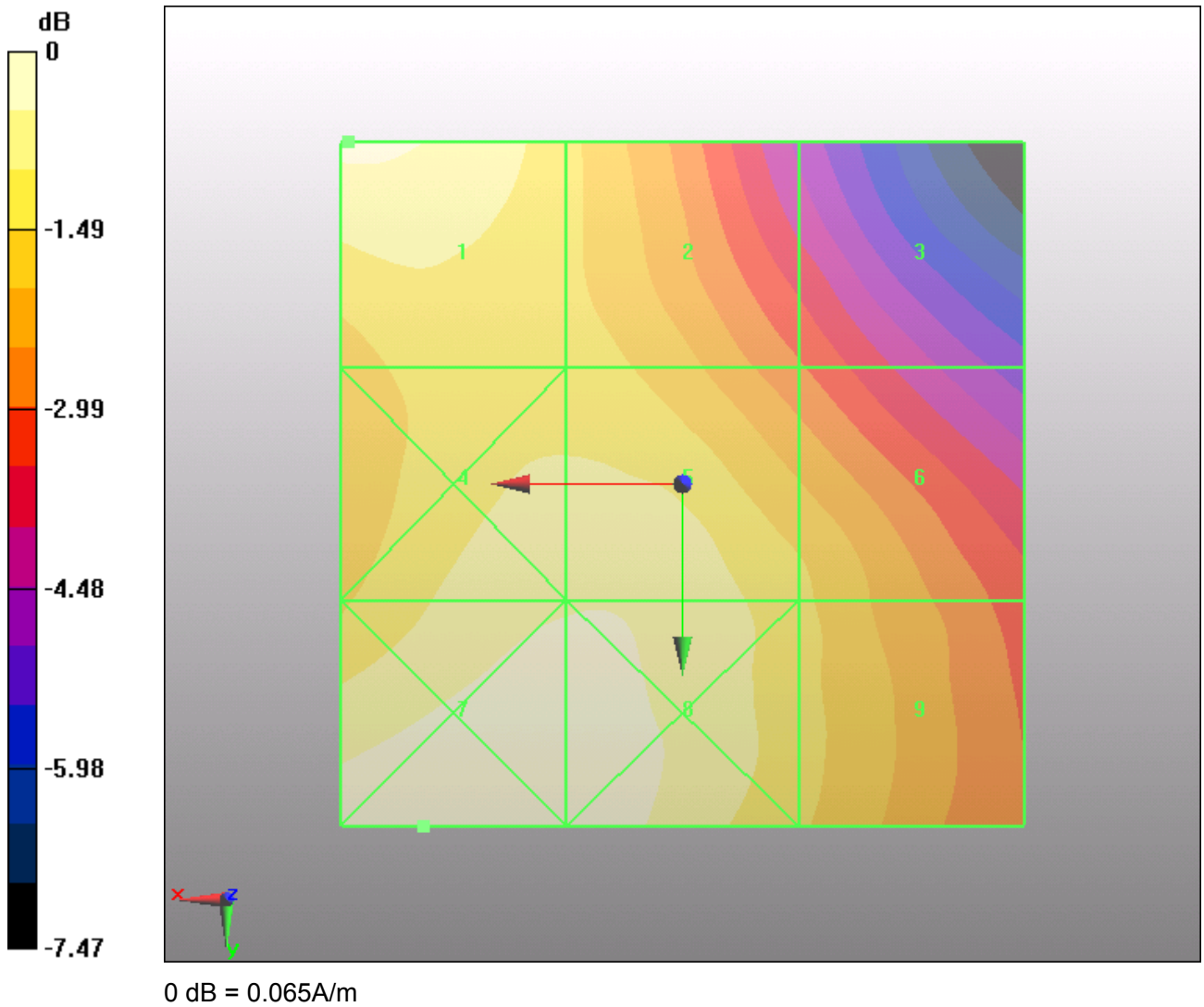


Figure 23 HAC RF H-Field CDMA PCS Channel 25

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 54 of 104

HAC RF E-Field CDMA AWS High

Date/Time: 11/11/2011 12:46:57 PM

Communication System: CDMA ; Frequency: 1752.5 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2302; ConvF(1, 1, 1); Calibrated: 06/15/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

M920 CDMA AWS HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 28.7 V/m

Probe Modulation Factor = 1.03

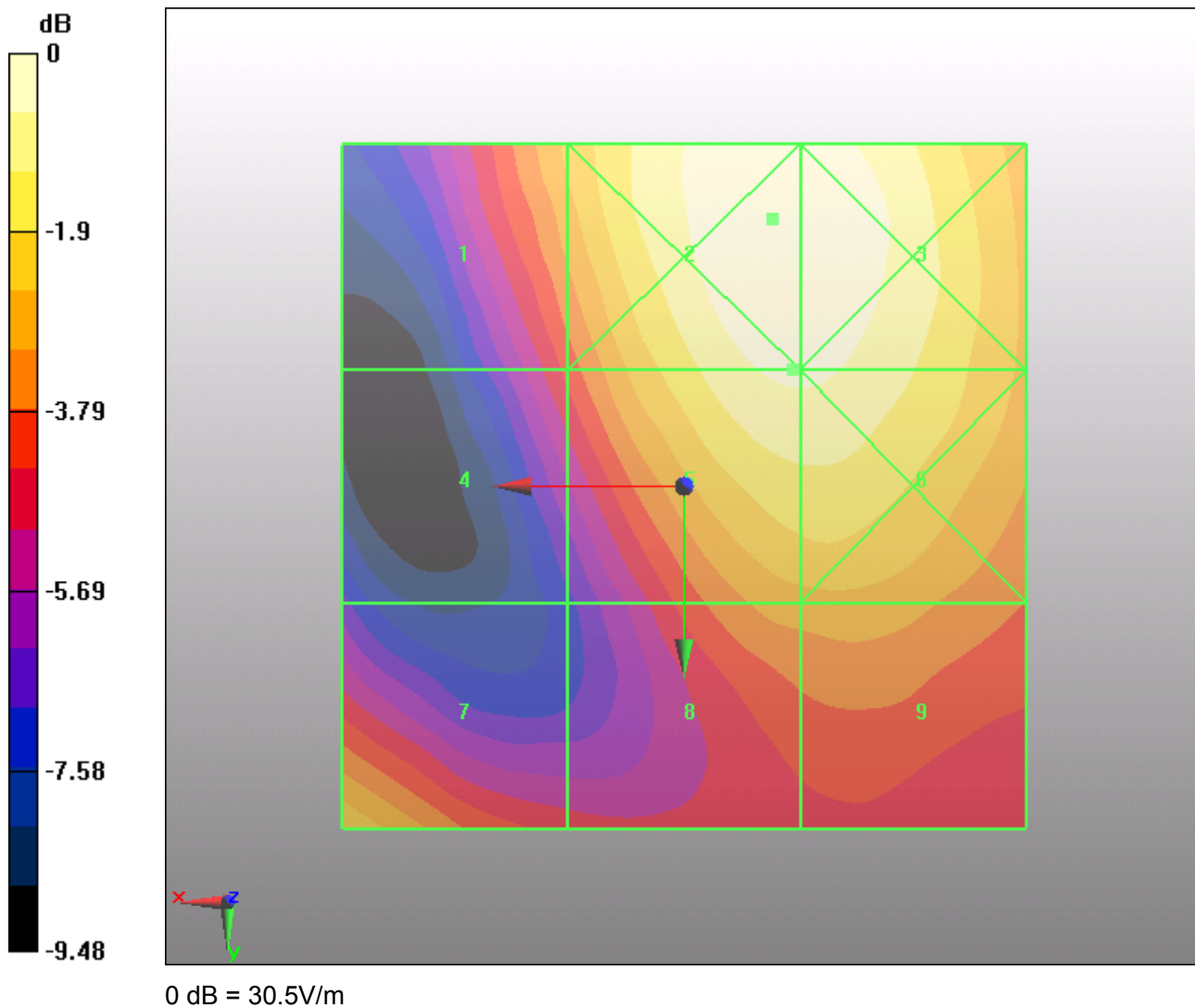
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 28.3 V/m; Power Drift = 0.151 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
23.3 M4	30.5 M4	30.3 M4
Grid 4	Grid 5	Grid 6
18.9 M4	28.7 M4	28.7 M4
Grid 7	Grid 8	Grid 9
24.4 M4	22.1 M4	22.4 M4



TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 56 of 104

HAC RF E-Field CDMA AWS Middle

Date/Time: 11/11/2011 12:41:18 PM

Communication System: CDMA ; Frequency: 1732.5 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2302; ConvF(1, 1, 1); Calibrated: 06/15/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

M920 CDMA AWS HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 26.8 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 26.5 V/m; Power Drift = 0.027 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1 22.7 M4	Grid 2 28.8 M4	Grid 3 28.6 M4
Grid 4 17.7 M4	Grid 5 26.8 M4	Grid 6 26.8 M4
Grid 7 22.7 M4	Grid 8 19.4 M4	Grid 9 19.6 M4

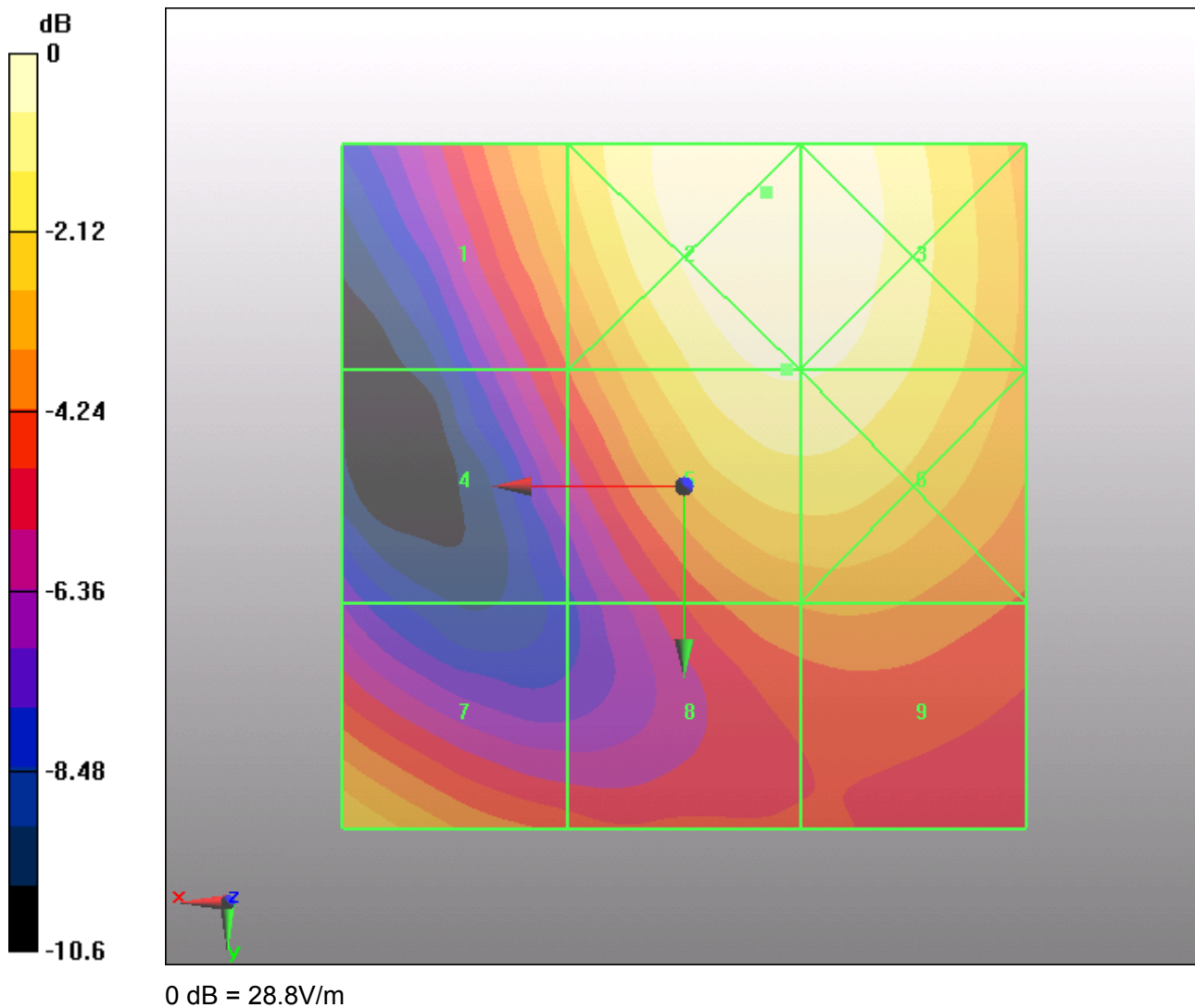


Figure 25 HAC RF E-Field CDMA AWS Channel 450

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 58 of 104

HAC RF E-Field CDMA AWS Low

Date/Time: 11/11/2011 12:52:20 PM

Communication System: CDMA ; Frequency: 1711.25 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2302; ConvF(1, 1, 1); Calibrated: 06/15/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

M920 CDMA AWS HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 30 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 30.1 V/m; Power Drift = 0.048 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
27.3 M4	32.7 M4	32.4 M4
Grid 4	Grid 5	Grid 6
21.6 M4	30 M4	29.8 M4
Grid 7	Grid 8	Grid 9
23.3 M4	20.6 M4	20.8 M4

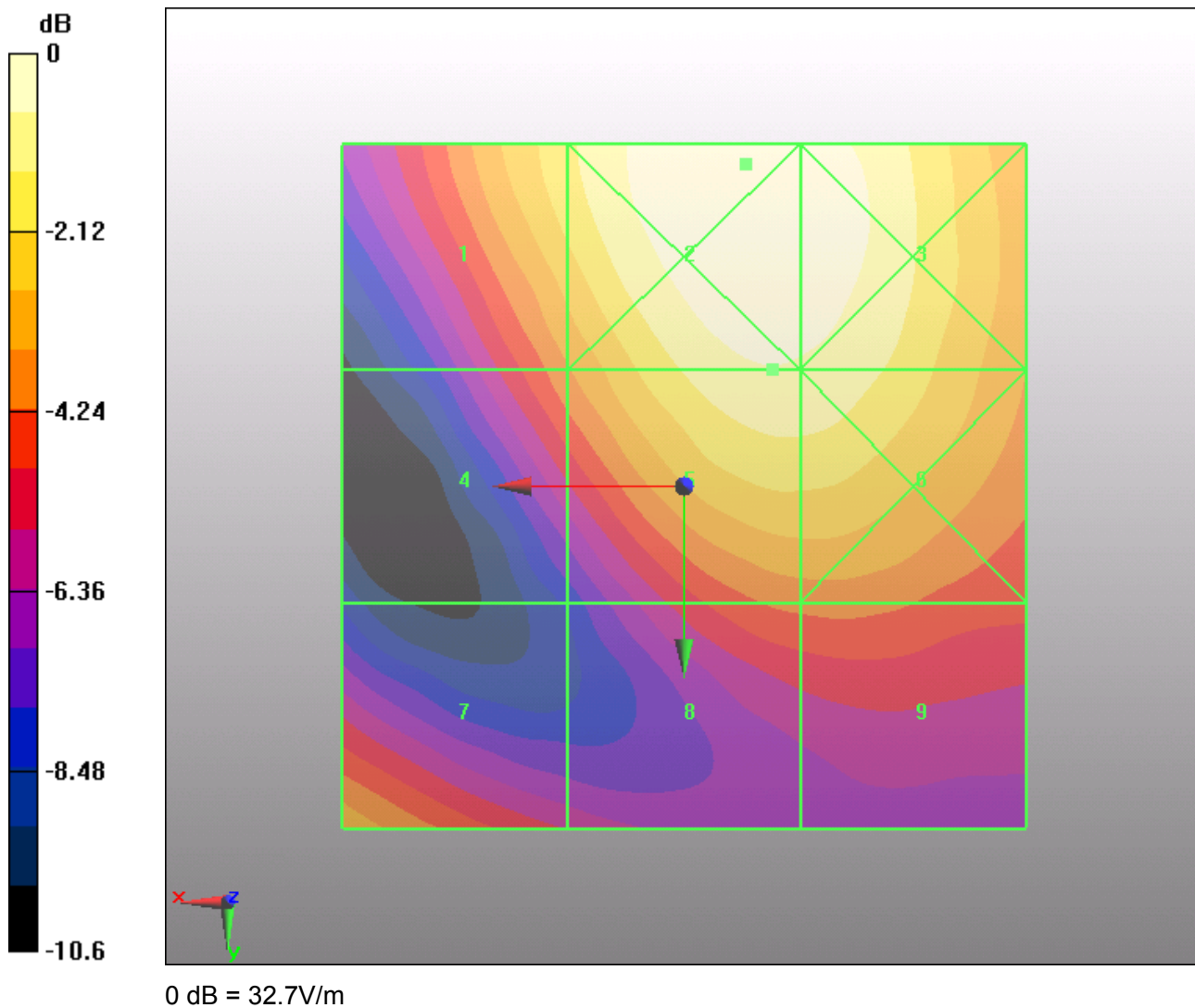


Figure 26 HAC RF E-Field CDMA AWS Channel 25

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 60 of 104

HAC RF H-Field CDMA AWS High

Date/Time: 11/11/2011 2:18:12 PM

Communication System: CDMA ; Frequency: 1752.5 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6187 ; Calibrated: 06/17/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

M920 CDMA AWS HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.073 A/m

Probe Modulation Factor = 1

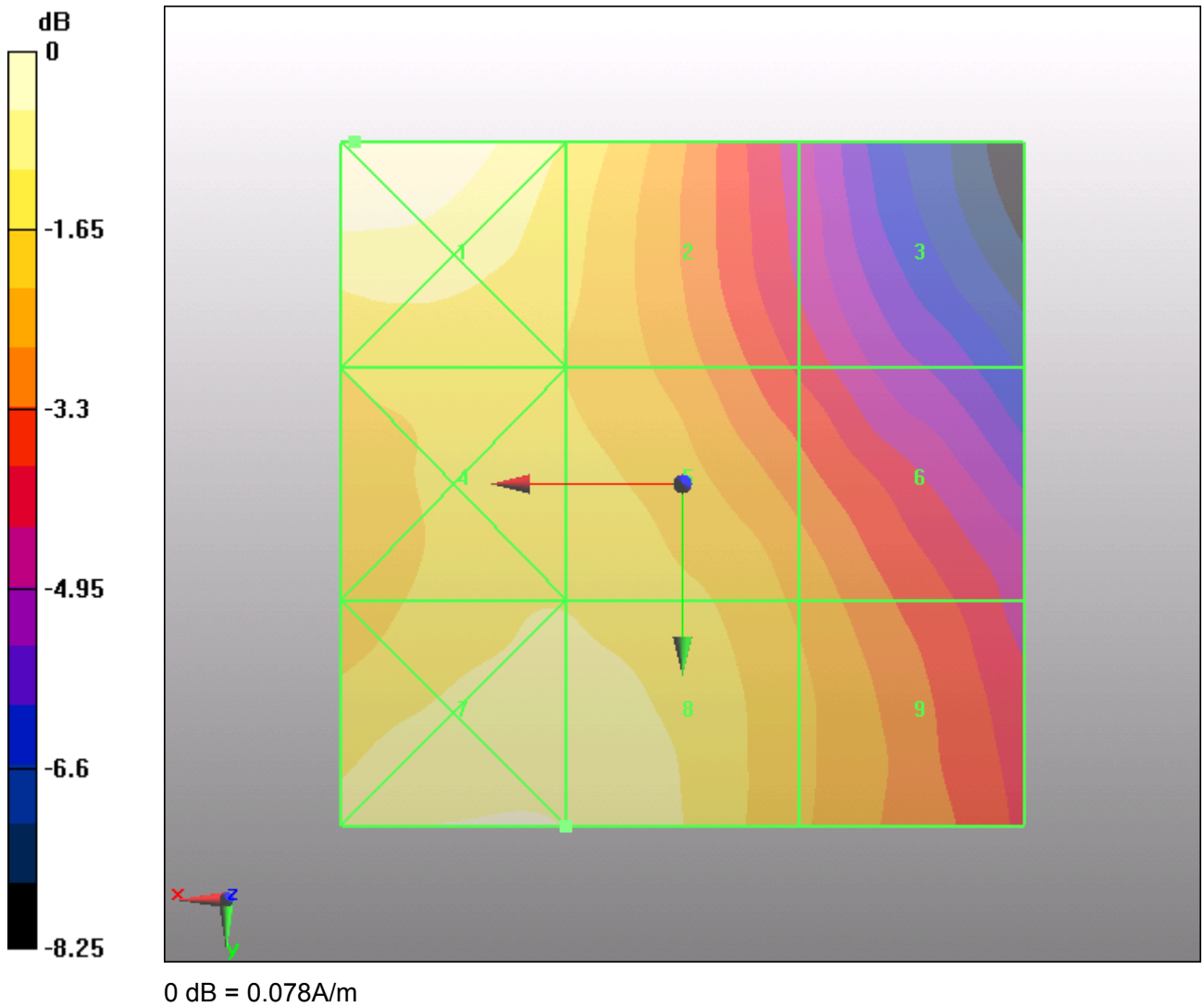
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.068 A/m; Power Drift = 0.043 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.078 M4	Grid 2 0.068 M4	Grid 3 0.050 M4
Grid 4 0.068 M4	Grid 5 0.068 M4	Grid 6 0.060 M4
Grid 7 0.074 M4	Grid 8 0.073 M4	Grid 9 0.062 M4



TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 62 of 104

HAC RF H-Field CDMA AWS Middle

Date/Time: 11/11/2011 2:12:49 PM

Communication System: CDMA ; Frequency: 1732.5 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6187 ; Calibrated: 06/17/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

M920 CDMA AWS HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.067 A/m

Probe Modulation Factor = 1

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.066 A/m; Power Drift = 0.090 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.075 M4	Grid 2 0.065 M4	Grid 3 0.048 M4
Grid 4 0.065 M4	Grid 5 0.065 M4	Grid 6 0.058 M4
Grid 7 0.067 M4	Grid 8 0.067 M4	Grid 9 0.059 M4

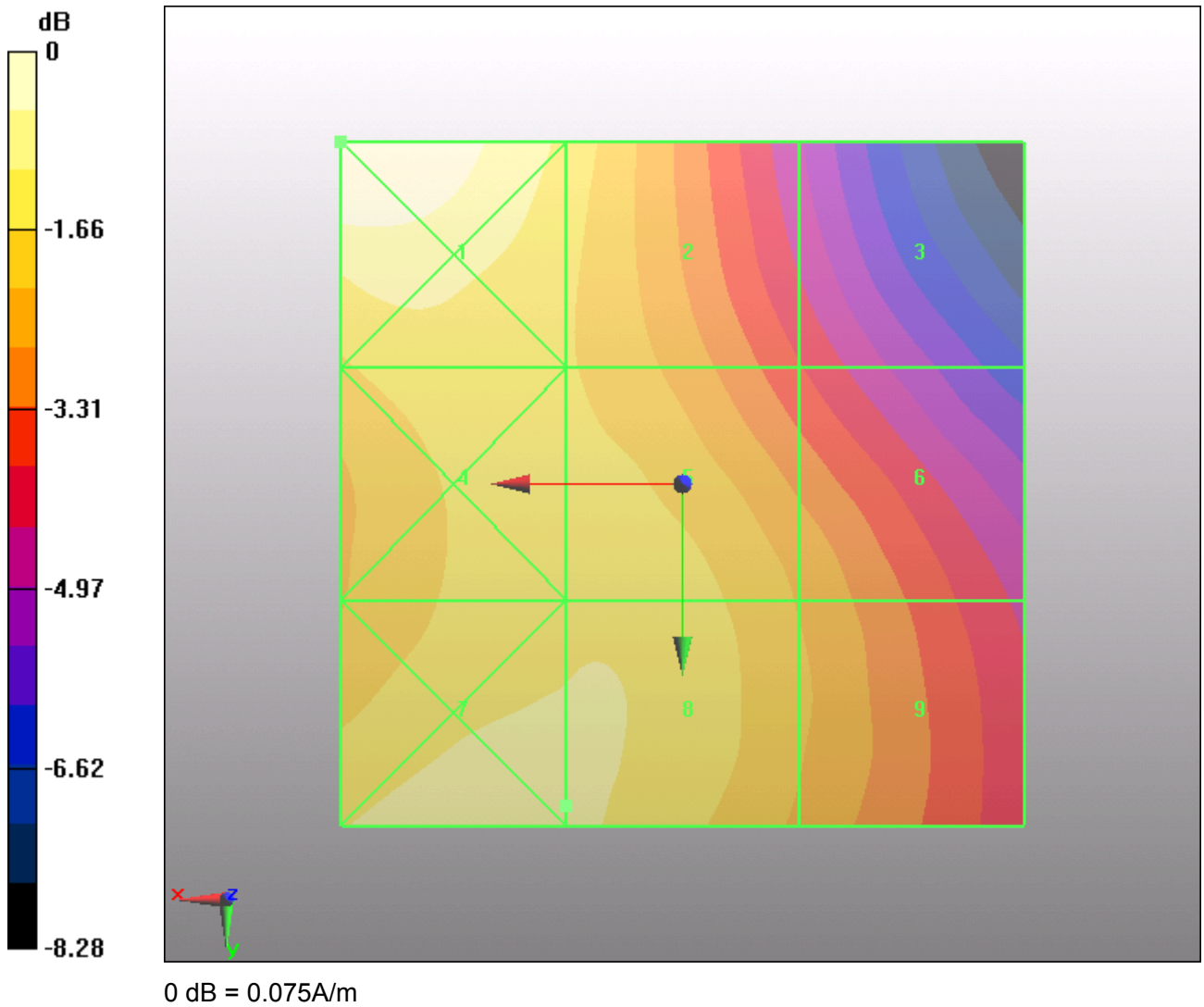


Figure 28 HAC RF H-Field CDMA AWS Channel 450

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 64 of 104

HAC RF H-Field CDMA AWS Low

Date/Time: 11/11/2011 2:23:35 PM

Communication System: CDMA ; Frequency: 1711.25 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6187 ; Calibrated: 06/17/2011

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

M920 CDMA AWS HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.071 A/m

Probe Modulation Factor = 1

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.075 A/m; Power Drift = -0.052 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.082 M4	Grid 2 0.069 M4	Grid 3 0.052 M4
Grid 4 0.071 M4	Grid 5 0.071 M4	Grid 6 0.063 M4
Grid 7 0.071 M4	Grid 8 0.071 M4	Grid 9 0.063 M4

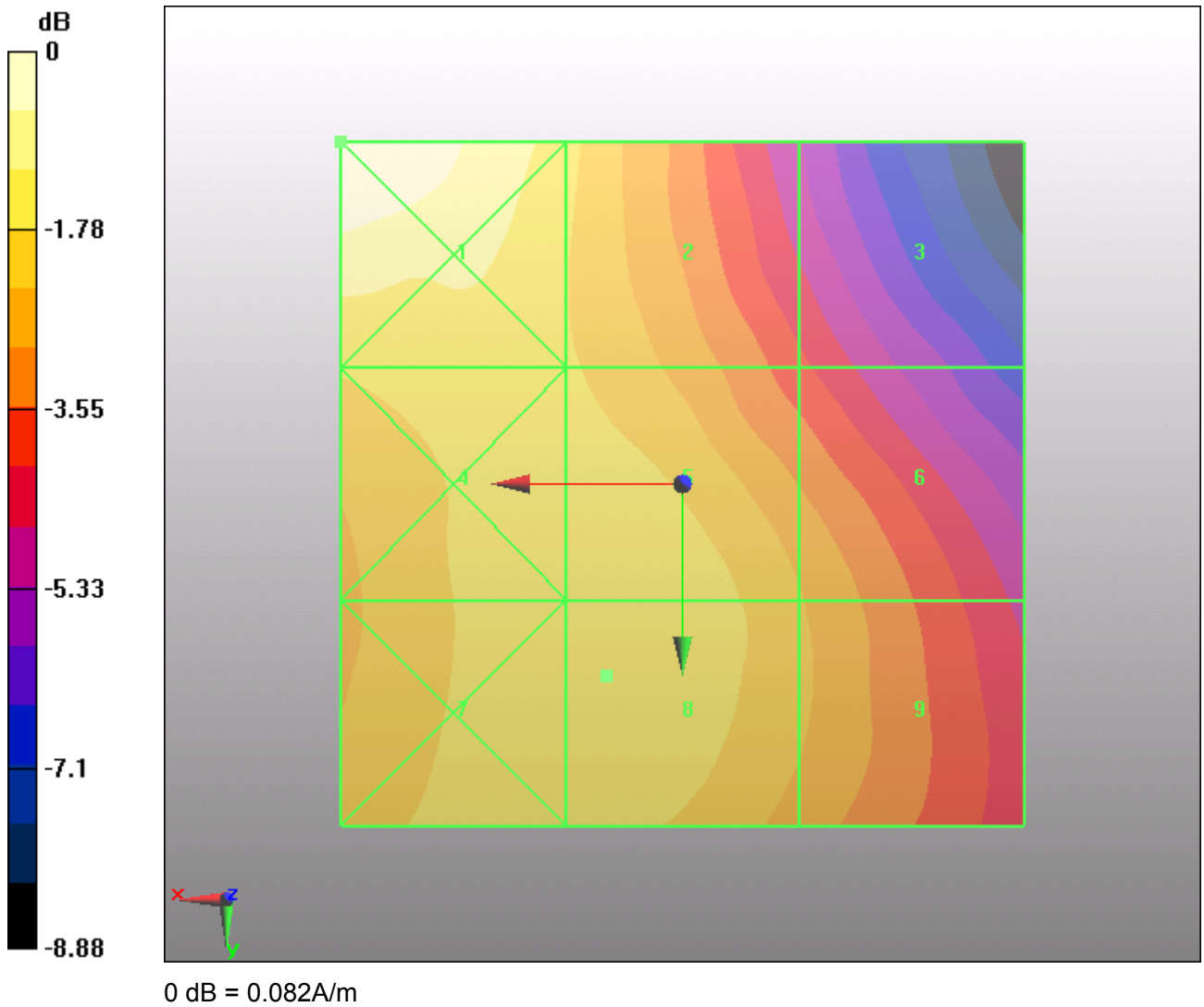


Figure 29 HAC RF H-Field CDMA AWS Channel 25

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 66 of 104

ANNEX C: E-Probe Calibration Certificate

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
S Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Client

Auden

Certificate No: ER3-2302_Jun11

CALIBRATION CERTIFICATE

Object: ER3DV6 - SN:2302

Calibration procedure(s): QA CAL-02.v6, QA CAL-25.v4
Calibration procedure for E-field probes optimized for close near field
evaluations in air.

Calibration date: June 15, 2011

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	31-Mar-11 (No. 217-01372)	Apr-12
Power sensor E4412A	MY41498087	31-Mar-11 (No. 217-01372)	Apr-12
Reference 3 dB Attenuator	SN: S5054 (3c)	29-Mar-11 (No. 217-01369)	Apr-12
Reference 20 dB Attenuator	SN: S5086 (20b)	29-Mar-11 (No. 217-01367)	Apr-12
Reference 30 dB Attenuator	SN: S5129 (30b)	29-Mar-11 (No. 217-01370)	Apr-12
Reference Probe ER3DV6	SN: 2328	4-Oct-10 (No. ER3-2328_Oct10)	Oct-11
DAE4	SN: 789	6-Apr-11 (No. DAE4-789_Apr11)	Apr-12
Secondary Standards	ID	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642UD1700	4-Aug-99 (in house check Oct-09)	In house check: Oct-11
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-10)	In house check: Oct-11

	Name	Function	Signature
Calibrated by:	Jeton Kasrat	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	
This calibration certificate shall not be reproduced except in full without written approval of the laboratory.			
Issued: June 17, 2011			

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 67 of 104

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary:

NORM _{x,y,z}	sensitivity in free space
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C	modulation dependent linearization parameters
Polarization ϕ	ϕ rotation around probe axis
Polarization θ	θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\theta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\theta = 0$ for XY sensors and $\theta = 90$ for Z sensor ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide).
- NORM(f)_{x,y,z}** = NORM_{x,y,z} * frequency_response (see Frequency Response Chart).
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR**: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; VR_{x,y,z}**: A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy)**: in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle**: The angle is assessed using the information gained by determining the NORM_x (no uncertainty required).

ER3DV6 – SN:2302

June 15, 2011

Probe ER3DV6

SN:2302

Manufactured: November 6, 2002
Calibrated: June 15, 2011

Calibrated for DASY/EASY Systems
(Note: non-compatible with DASY2 system!)

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 69 of 104

ER3DV6- SN:2302

June 15, 2011

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2302

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ($\mu V/(V/m)^2$)	1.47	1.34	1.44	$\pm 10.1 \%$
DCP (mV) ^a	98.2	96.7	101.8	

Modulation Calibration Parameters

UID	Communication System Name	PAR		A dB	B dB	C dB	VR mV	Unc ^E (k=2)
10000	CW	0.00	X	0.00	0.00	1.00	113.8	$\pm 3.0 \%$
			Y	0.00	0.00	1.00	99.1	
			Z	0.00	0.00	1.00	95.3	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^a Numerical linearization parameter: uncertainty not required.

^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

TA Technology (Shanghai) Co., Ltd.
Test Report

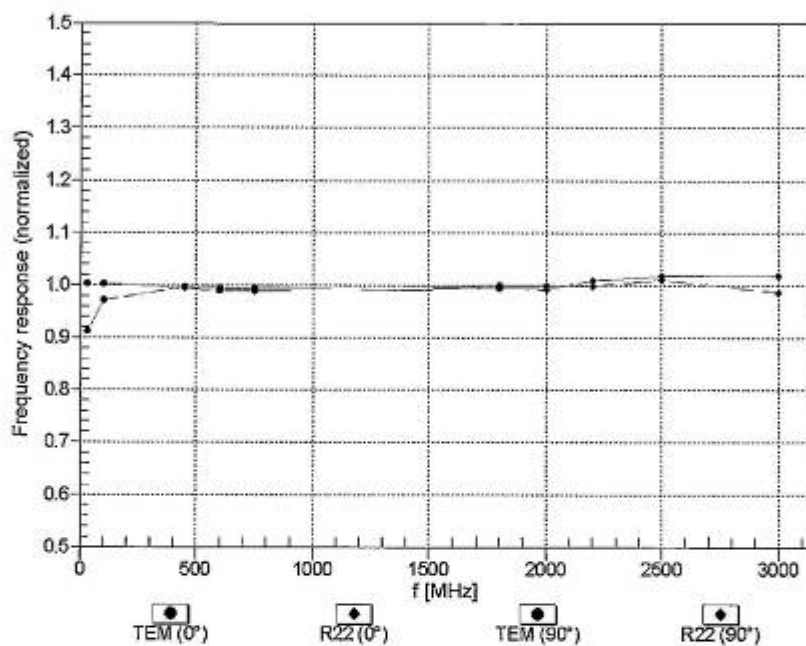
Report No. RZA1111-1887HAC01

Page 70 of 104

ER3DV6-SN:2302

June 15, 2011

Frequency Response of E-Field
(TEM-Cell:ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

TA Technology (Shanghai) Co., Ltd.
Test Report

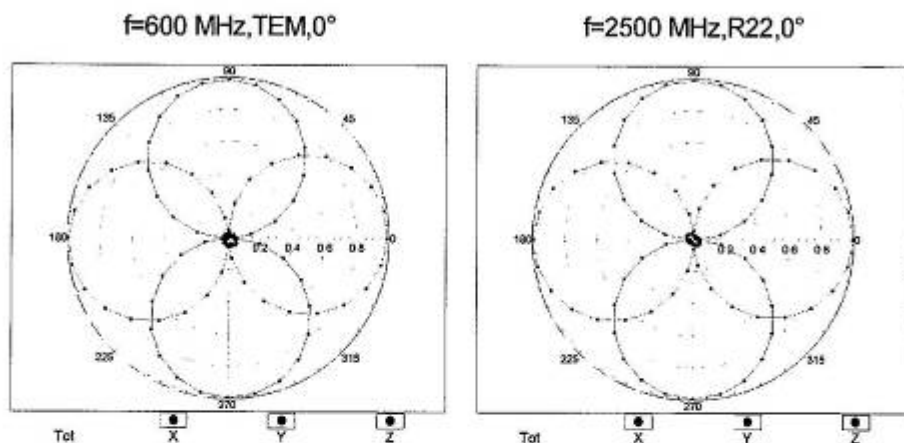
Report No. RZA1111-1887HAC01

Page 71 of 104

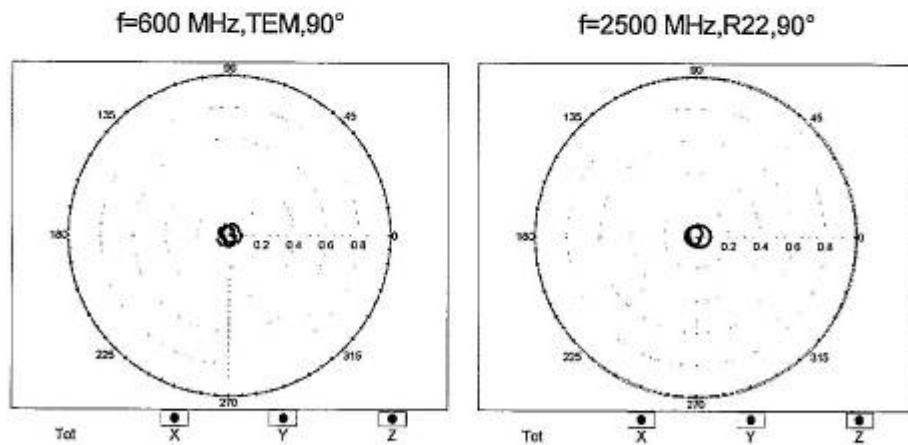
ER3DV6- SN:2302

June 15, 2011

Receiving Pattern (ϕ), $\theta = 0^\circ$



Receiving Pattern (ϕ), $\theta = 90^\circ$



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Test Report

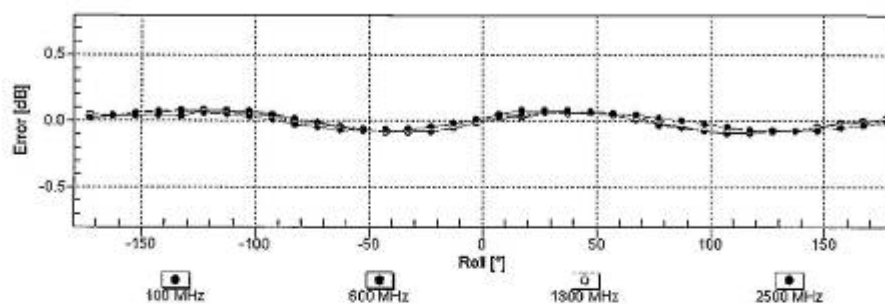
Report No. RZA1111-1887HAC01

Page 72 of 104

ER3DV6- SN:2302

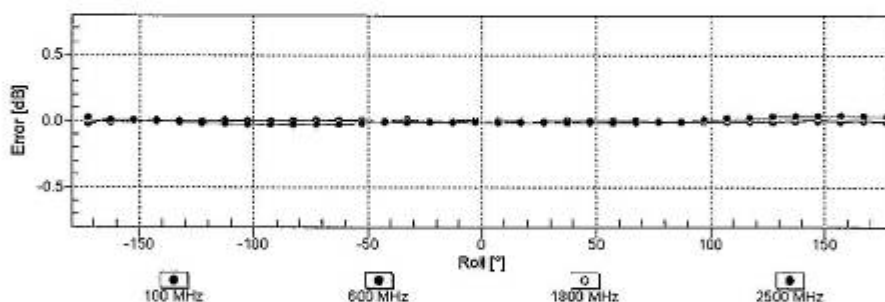
June 15, 2011

Receiving Pattern (ϕ), $\vartheta = 0^\circ$



Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

Receiving Pattern (ϕ), $\vartheta = 90^\circ$



Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

TA Technology (Shanghai) Co., Ltd. Test Report

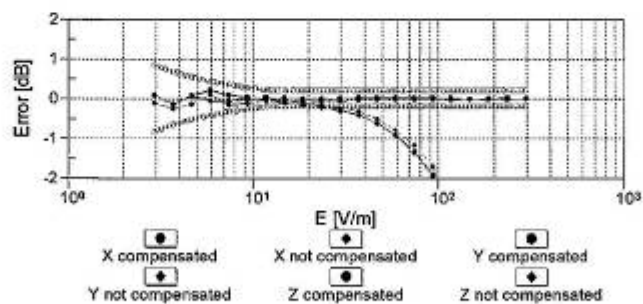
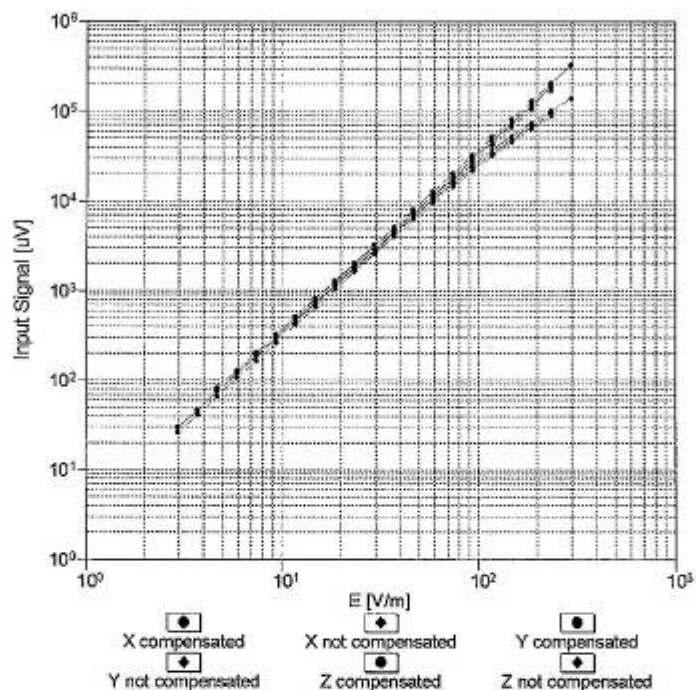
Report No. RZA1111-1887HAC01

Page 73 of 104

ER3DV6-SN:2302

June 15, 2011

Dynamic Range f(E-field) (TEM cell, f = 900 MHz)



Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

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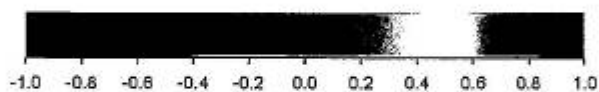
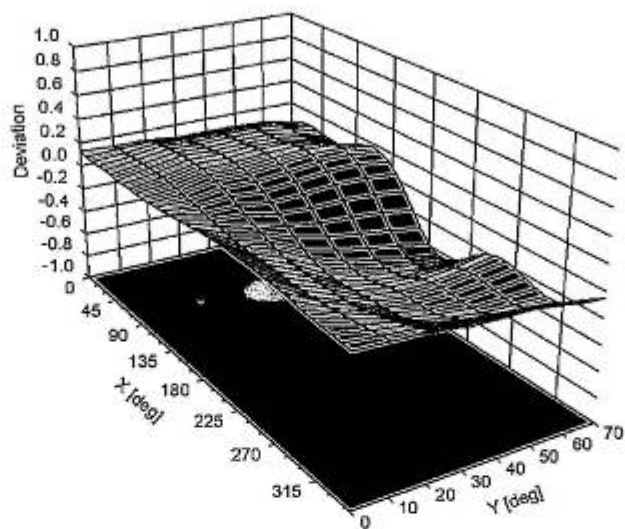
Report No. RZA1111-1887HAC01

Page 74 of 104

ER3DV6-SN:2302

June 15, 2011

Deviation from Isotropy in Air
Error (ϕ , θ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ ($k=2$)

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Report No. RZA1111-1887HAC01

Page 75 of 104

ER3DV6- SN:2302

June 15, 2011

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2302

Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (°)	-2.7
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	8 mm
Probe Tip to Sensor X Calibration Point	2.5 mm
Probe Tip to Sensor Y Calibration Point	2.5 mm
Probe Tip to Sensor Z Calibration Point	2.5 mm

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Test Report

Report No. RZA1111-1887HAC01

Page 76 of 104

ANNEX D: H-Probe Calibration Certificate

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: SCS 108

Client

Auden

Certificate No: H3-6187_Jun11

CALIBRATION CERTIFICATE

Object H3DV6 - SN:6187

Calibration procedure(s) QA-CAL-03.v6; QA-CAL-25.v4
Calibration procedure for H-field probes optimized for close near field
evaluations in air

Calibration date: June 17, 2011

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293674	31-Mar-11 (No. 217-01372)	Apr-12
Power sensor E4412A	MY41488087	31-Mar-11 (No. 217-01372)	Apr-12
Reference 3 dB Attenuator	SN: S5054 (3c)	29-Mar-11 (No. 217-01369)	Apr-12
Reference 20 dB Attenuator	SN: S5086 (20b)	29-Mar-11 (No. 217-01367)	Apr-12
Reference 30 dB Attenuator	SN: S5129 (30b)	29-Mar-11 (No. 217-01370)	Apr-12
Reference Probe H3DV6	SN: 6182	4-Oct-10 (No. H3-6182_Oct10)	Oct-11
DAE4	SN: 789	6-Apr-11 (No. DAE4-789_Apr11)	Apr-12
Secondary Standards	ID	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Oct-09)	In house check: Oct-11
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-10)	In house check: Oct-11

	Name	Function	Signature
Calibrated by:	Claudio Leubler	Laboratory Technician	
Approved by:	Karla Pokovic	Technical Manager	
Issued: June 17, 2011			
This calibration certificate shall not be reproduced except in full without written approval of the laboratory.			

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Test Report

Report No. RZA1111-1887HAC01

Page 77 of 104

**Calibration Laboratory of
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Zeughausstrasse 43, 8004 Zurich, Switzerland



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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary:

NORM _{x,y,z}	sensitivity in free space
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C	modulation dependent linearization parameters
Polarization ϕ	ϕ rotation around probe axis
Polarization θ	θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\theta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\theta = 0$ for XY sensors and $\theta = 90$ for Z sensor ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide).
- X, Y, Z(f)**: $X, Y, Z_{a0a1a2} = X, Y, Z_{a0a1a2} \cdot \text{frequency_response}$ (see Frequency Response Chart).
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR**: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; VR_{x,y,z}**: A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy)**: in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle**: The angle is assessed using the information gained by determining the X_{a0a1a2} (no uncertainty required).

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 78 of 104

H3DV6 – SN:6187

June 17, 2011

Probe H3DV6

SN:6187

Manufactured: June 8, 2004
Calibrated: June 17, 2011

Calibrated for DASY/EASY Systems
(Note: non-compatible with DASY2 system!)

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 79 of 104

H3DV6- SN:6187

June 17, 2011

DASY/EASY - Parameters of Probe: H3DV6 - SN:6187

Basic Calibration Parameters

		Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm (A/m / $\sqrt{\text{mV}}$)	a0	3.25E-003	2.53E-003	3.06E-003	$\pm 5.1 \%$
Norm (A/m / $\sqrt{\text{mV}}$)	a1	-2.03E-005	4.43E-005	-4.88E-005	$\pm 5.1 \%$
Norm (A/m / $\sqrt{\text{mV}}$)	a2	2.36E-005	1.59E-005	7.21E-005	$\pm 5.1 \%$
DCP (mV) ^B		108.1	92.6	91.8	

Modulation Calibration Parameters

UID	Communication System Name	PAR		A dB	B dB	C dB	VR mV	Unc ^E (k=2)
10000	CW	0.00	X	0.00	0.00	1.00	77.7	$\pm 3.0 \%$
			Y	0.00	0.00	1.00	72.9	
			Z	0.00	0.00	1.00	90.7	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^B Numerical linearization parameter; uncertainty not required.

^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

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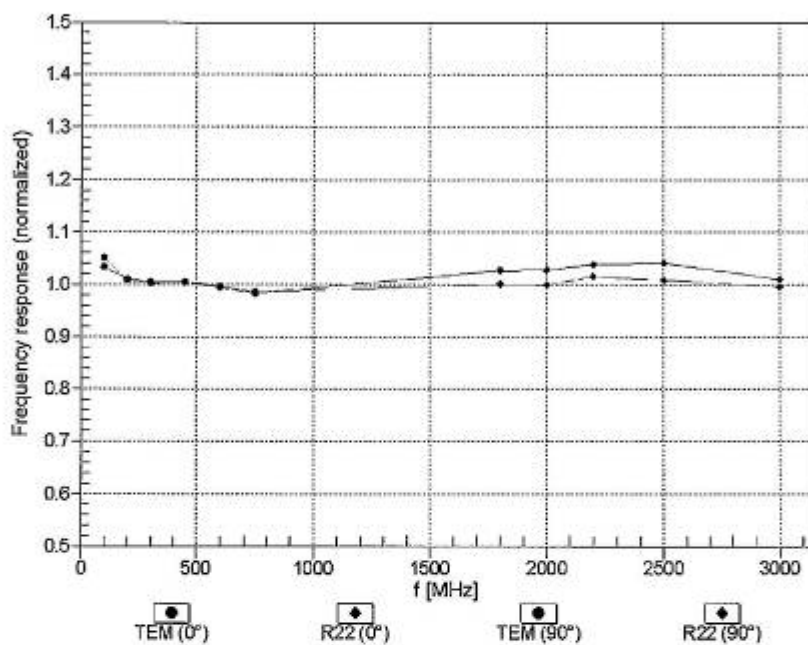
Report No. RZA1111-1887HAC01

Page 80 of 104

H3DV6- SN:6187

June 17, 2011

Frequency Response of H-Field
(TEM-Cell:ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of H-field: $\pm 6.3\%$ (k=2)

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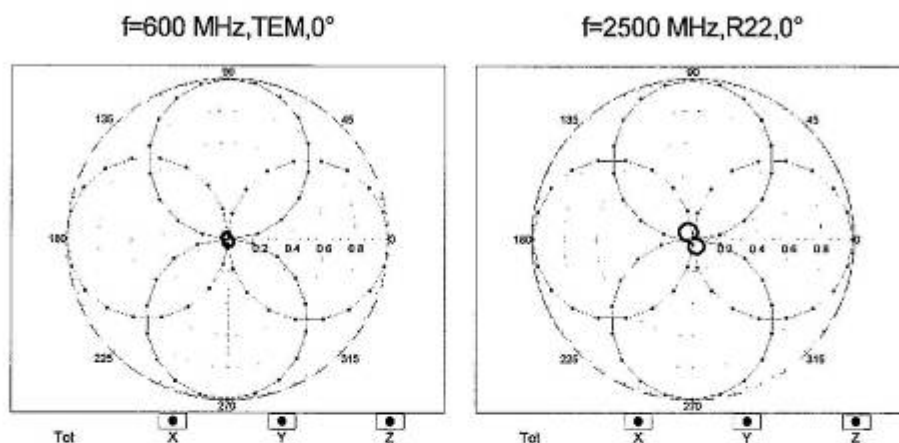
Report No. RZA1111-1887HAC01

Page 81 of 104

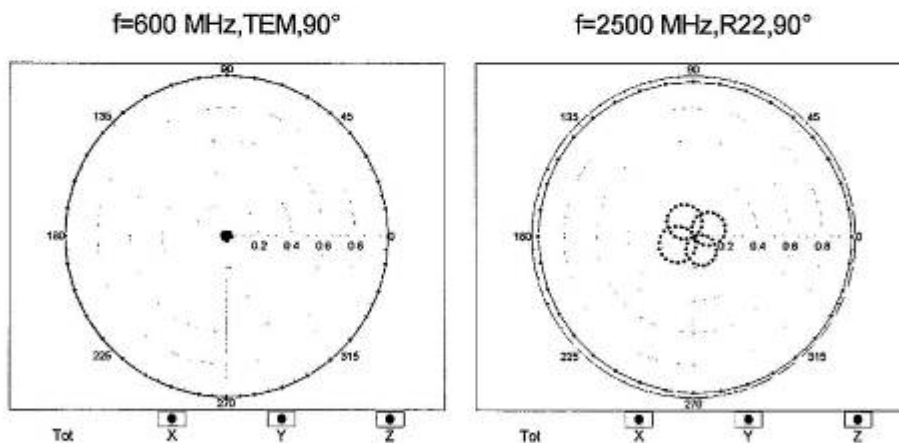
H3DV6- SN:8187

June 17, 2011

Receiving Pattern (ϕ), $\theta = 0^\circ$



Receiving Pattern (ϕ), $\theta = 90^\circ$



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Test Report

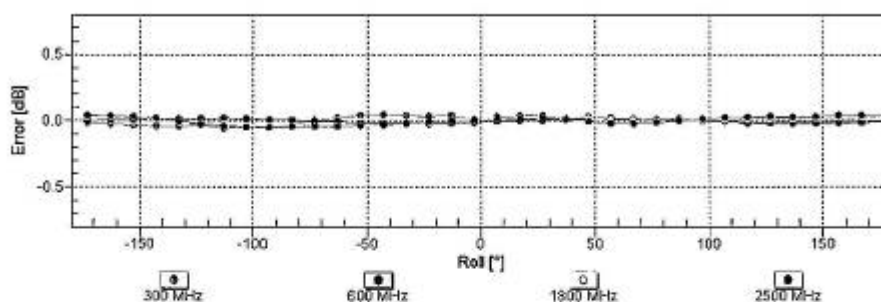
Report No. RZA1111-1887HAC01

Page 82 of 104

H3DV6- SN:6187

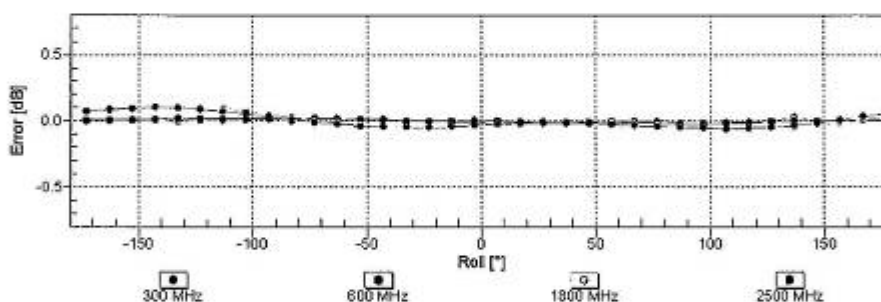
June 17, 2011

Receiving Pattern (ϕ), $\vartheta = 0^\circ$



Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

Receiving Pattern (ϕ), $\vartheta = 90^\circ$



Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

TA Technology (Shanghai) Co., Ltd. Test Report

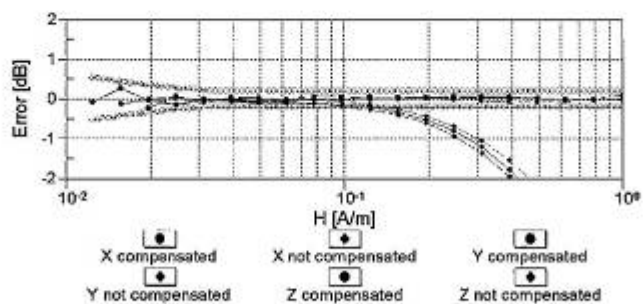
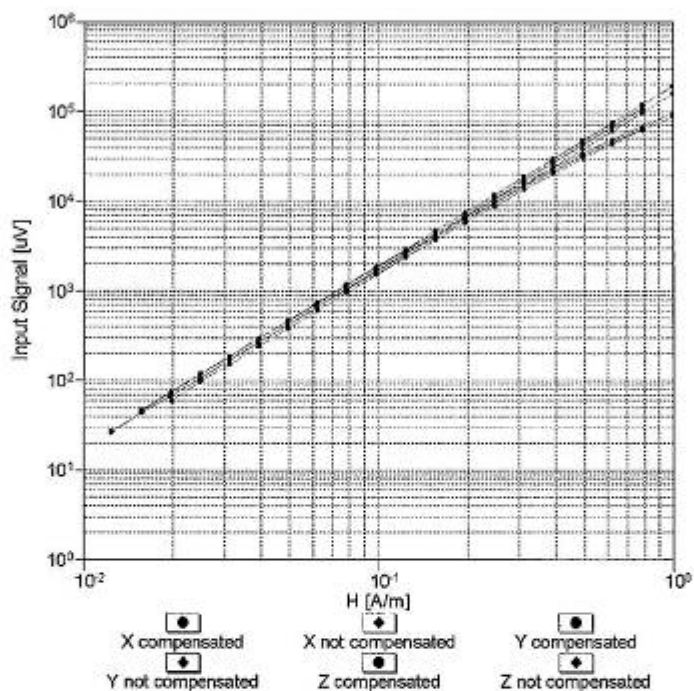
Report No. RZA1111-1887HAC01

Page 83 of 104

H3DV6- SN:6167

June 17, 2011

Dynamic Range f(H-field) (TEM cell, f = 900 MHz)



Uncertainty of Linearity Assessment: $\pm 0.6\%$ (k=2)

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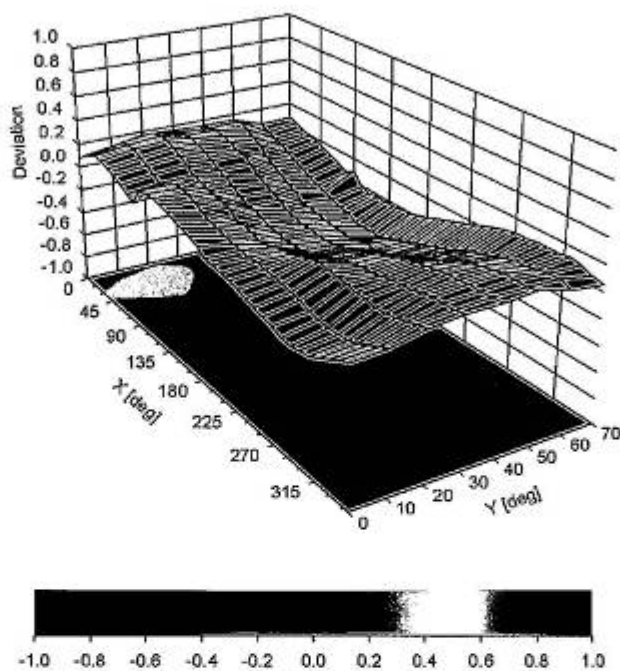
Report No. RZA1111-1887HAC01

Page 84 of 104

H3DV6- SN:6167

June 17, 2011

Deviation from Isotropy in Air
Error (ϕ , θ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ ($k=2$)

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Test Report

Report No. RZA1111-1887HAC01

Page 85 of 104

H3DV6- SN:6187

June 17, 2011

DASY/EASY - Parameters of Probe: H3DV6 - SN:6187

Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (°)	-113
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	20 mm
Tip Diameter	6 mm
Probe Tip to Sensor X Calibration Point	3 mm
Probe Tip to Sensor Y Calibration Point	3 mm
Probe Tip to Sensor Z Calibration Point	3 mm

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Test Report

Report No. RZA1111-1887HAC01

Page 86 of 104

ANNEX E: CD835V3 Dipole Calibration Certificate

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **TA Technology (Auden)**

Certificate No: **CD835V3-1133_Apr09**

CALIBRATION CERTIFICATE

Object **CD835V3 - SN: 1133**

Calibration procedure(s) **QA CAL-20.v4**
Calibration procedure for dipoles in air

Calibration date: **April 22, 2009**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
All calibrations have been conducted in the closed laboratory facility; environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	08-Oct-08 (No. 217-00898)	Oct-09
Power sensor HP 8481A	US37292783	08-Oct-08 (No. 217-00898)	Oct-09
Probe ER3DV6	SN: 2336	22-Dec-08 (No. ER3-2336_Dec08)	Dec-09
Probe H3DV6	SN: 6065	22-Dec-08 (No. H3-6065_Dec08)	Dec-09
DAE4	SN: 781	20-Feb-09 (No. DAE4-781_Feb09)	Feb-10
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power meter R&S NRP	SN: 101748	23-Sep-08 (in house check Dec-08)	In house check: Dec-10
Power sensor R&S NRP-Z91	SN: 100711	25-Aug-08 (in house check Dec-08)	In house check: Dec-10
Power sensor R&S NRP-Z91	SN: 100712	25-Aug-08 (in house check Dec-08)	In house check: Dec-10
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-08)	In house check: Oct-09
RF generator E4433B	MY 41310391	03-Nov-04 (in house check Oct-07)	In house check: Oct-09

Calibrated by: **Name** **Function** **Signature**
Mike Melli **Laboratory Technician**

Approved by: **Fin Bornholt** **Technical Director**

Issued: April 24, 2009

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Test Report

Report No. RZA1111-1887HAC01

Page 87 of 104

**Calibration Laboratory of
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Zeughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: **SCS 108**

References

- [1] ANSI-C63.19-2006
American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.
- [2] ANSI-C63.19-2007
American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- **Coordinate System:** y-axis is in the direction of the dipole arms, z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1, 2], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- **Measurement Conditions:** Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- **Antenna Positioning:** The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY4 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- **Feed Point Impedance and Return Loss:** These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- **E-field distribution:** E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1, 2], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- **H-field distribution:** H-field is measured with an isotropic H-field probe with 100mW forward power to the antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the feed point.

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 88 of 104

1 Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY4	V4.7 B80
DASY PP Version	SEMCAD	V1.8 B186
Phantom	HAC Test Arch	SD HAC P01 BA, #1070
Distance Dipole Top - Probe Center	10 mm	
Scan resolution	dx, dy = 5 mm	area = 20 x 180 mm
Frequency	835 MHz $\pm$ 1 MHz	
Forward power at dipole connector	20.0 dBm = 100mW	
Input power drift	< 0.05 dB	

2 Maximum Field values

H-field 10 mm above dipole surface	condition	interpolated maximum
Maximum measured	100 mW forward power	0.446 A/m

Uncertainty for H-field measurement: 8.2% (k=2)

E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end-	100 mW forward power	158.2 V/m
Maximum measured above low end	100 mW forward power	157.3 V/m
Averaged maximum above arm	100 mW forward power	157.8 V/m

Uncertainty for E-field measurement: 12.8% (k=2)

3 Appendix

3.1 Antenna Parameters

Frequency	Return Loss	Impedance
800 MHz	18.2 dB	(43.3 – j12.9) Ohm
835 MHz	33.2 dB	(49.3 + j2.1) Ohm
900 MHz	17.4 dB	(53.5 – j13.6) Ohm
950 MHz	20.0 dB	(44.3 + j7.5) Ohm
960 MHz	14.8 dB	(53.2 + j18.8) Ohm

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

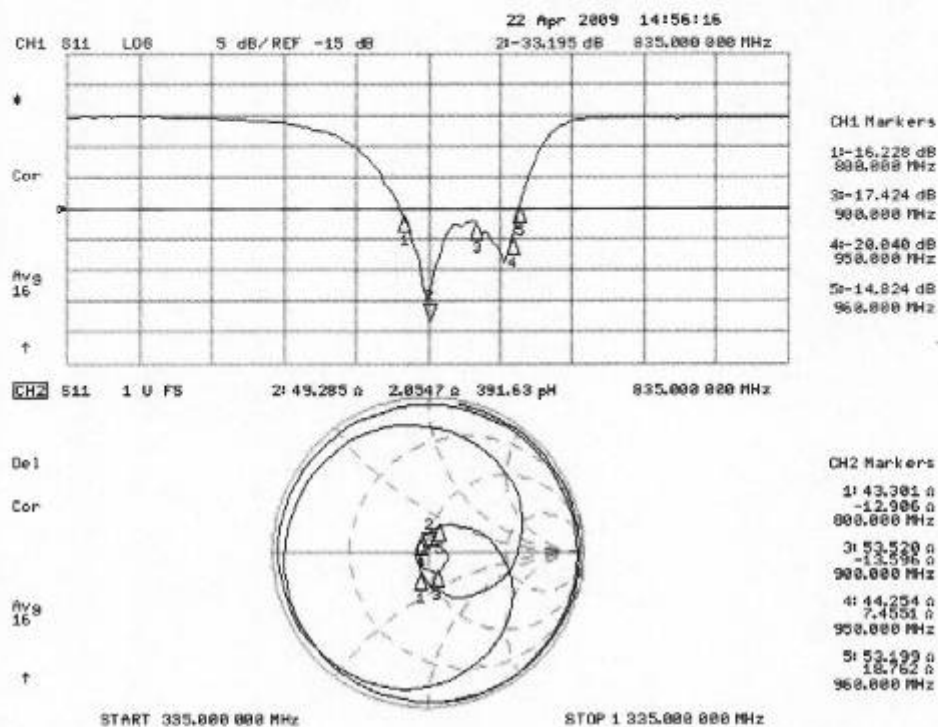
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Report No. RZA1111-1887HAC01

Page 89 of 104

3.3 Measurement Sheets

3.3.1 Return Loss and Smith Chart



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Test Report

Report No. RZA1111-1887HAC01

Page 90 of 104

3.3.2 DASY4 H-field Result

Date/Time: 21.04.2009 13:38:21

Test Laboratory: SPEAG Lab 2

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1133

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0 \text{ mho/m}$, $\epsilon_r = 1$; $\rho = 1 \text{ kg/m}^3$

Phantom section: RF Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: H3DV6 - SN6065; ; Calibrated: 22.12.2008
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 20.02.2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid Compatibility Test (41x361x1):

Measurement grid: $dx=5\text{mm}$, $dy=5\text{mm}$

Maximum value of peak Total field = 0.446 A/m

Probe Modulation Factor = 1.00

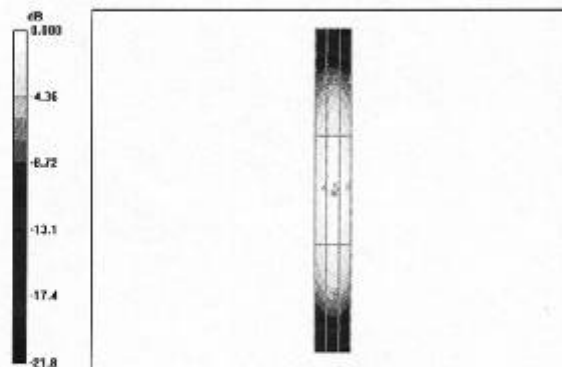
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.472 A/m; Power Drift = -0.006 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.364 M4	0.385 M4	0.368 M4
Grid 4	Grid 5	Grid 6
0.417 M4	0.446 M4	0.426 M4
Grid 7	Grid 8	Grid 9
0.365 M4	0.393 M4	0.376 M4



0 dB = 0.446 A/m

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 91 of 104

3.3.3 DASY4 E-field Result

Date/Time: 22.04.2009 12:51:53

Test Laboratory: SPEAG Lab 2

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1133

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 22.12.2008
- Sensor-Surface: (Fix Surface)
- Electronics: DA64 Sn781; Calibrated: 20.02.2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid Compatibility Test (41x361x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 158.2 V/m

Probe Modulation Factor = 1.00

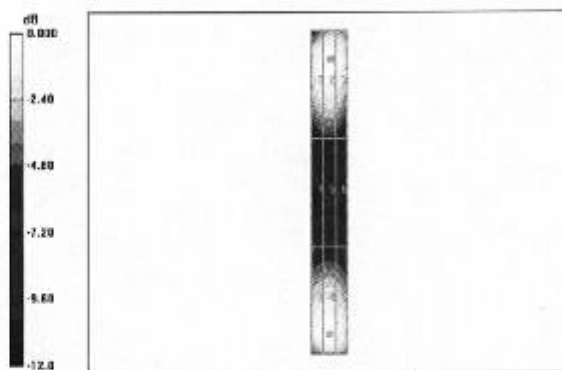
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 105.8 V/m; Power Drift = -0.013 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
152.4 M4	158.2 M4	154.6 M4
Grid 4	Grid 5	Grid 6
84.6 M4	86.9 M4	84.2 M4
Grid 7	Grid 8	Grid 9
151.7 M4	157.3 M4	152.4 M4



0 dB = 158.2V/m

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01

Page 92 of 104

ANNEX F: CD1880V3 Dipole Calibration Certificate

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



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Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Client TA Technology (Auden)

Certificate No: CD1880V3-1115_Apr09

CALIBRATION CERTIFICATE

Object CD1880V3 - SN: 1115

Calibration procedure(s) QA CAL-20.v4
Calibration procedure for dipoles in air

Calibration date: April 22, 2009

Condition of the calibrated item In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	08-Oct-08 (No. 217-00898)	Oct-09
Power sensor HP 8481A	US37292783	08-Oct-08 (No. 217-00898)	Oct-09
Probe ER3DV6	SN: 2336	22-Dec-08 (No. ER3-2336_Dec08)	Dec-09
Probe H3DV6	SN: 6065	22-Dec-08 (No. H3-6065_Dec08)	Dec-09
DAE4	SN 781	20-Feb-09 (No. DAE4-781_Feb09)	Feb-10

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power meter R&S NRP	SN: 101748	23-Sep-08 (in house check Dec-08)	In house check: Dec-10
Power sensor R&S NRP-Z91	SN: 100711	25-Aug-08 (in house check Dec-08)	In house check: Dec-10
Power sensor R&S NRP-Z91	SN: 100712	25-Aug-08 (in house check Dec-08)	In house check: Dec-10
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-08)	In house check: Oct-09
RF generator E4433B	MY 41310391	22-Nov-04 (in house check Oct-07)	In house check: Oct-09

Calibrated by: Name Mike Mehl Function Laboratory Technician Signature *[Signature]*

Approved by: Name Fin Bornholt Technical Director Signature *[Signature]*

Issued: April 24, 2009

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: CD1880V3-1115_Apr09

Page 1 of 6

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 93 of 104

Calibration Laboratory of
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Accreditation No.: **SCS 108**

References

- [1] ANSI-C63.19-2006
American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.
- [2] ANSI-C63.19-2007
American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- **Coordinate System:** y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1, 2], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- **Measurement Conditions:** Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- **Antenna Positioning:** The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY4 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- **Feed Point Impedance and Return Loss:** These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- **E-field distribution:** E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1, 2], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- **H-field distribution:** H-field is measured with an isotropic H-field probe with 100mW forward power to the antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the feed point.

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 94 of 104

1. Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY4	V4.7 B80
DASY PP Version	SEMCAD	V1.8 B186
Phantom	HAC Test Arch	SD HAC P01 BA, #1070
Distance Dipole Top - Probe Center	10 mm	
Scan resolution	dx, dy = 5 mm	area = 20 x 90 mm
Frequency	1880 MHz $\pm$ 1 MHz	
Forward power at dipole connector	20.0 dBm = 100mW	
Input power drift	< 0.05 dB	

2. Maximum Field values

H-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured	100 mW forward power	0.468 A/m

Uncertainty for H-field measurement: 8.2% (k=2)

E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW forward power	140.5 V/m
Maximum measured above low end	100 mW forward power	138.2 V/m
Averaged maximum above arm	100 mW forward power	139.4 V/m

Uncertainty for E-field measurement: 12.8% (k=2)

3. Appendix

3.1 Antenna Parameters

Frequency	Return Loss	Impedance
1710 MHz	24.0 dB	(52.4 + j6.0) Ohm
1880 MHz	21.4 dB	(46.8 + j7.6) Ohm
1900 MHz	22.4 dB	(48.1 + j7.2) Ohm
1950 MHz	30.1 dB	(50.1 + j3.1) Ohm
2000 MHz	18.4 dB	(40.5 + j5.4) Ohm

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

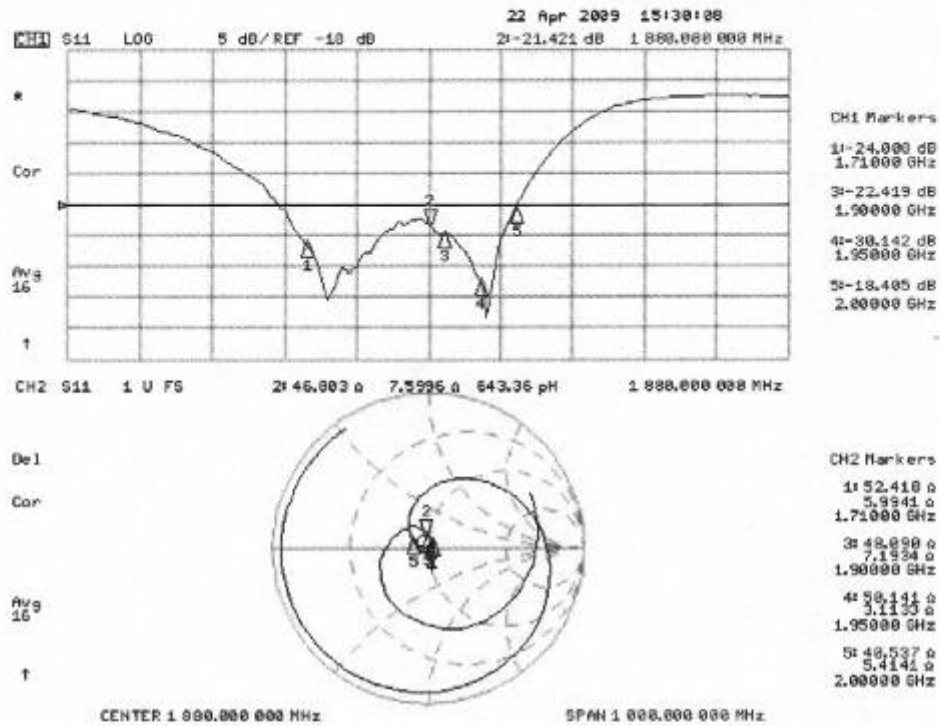
TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA1111-1887HAC01

Page 95 of 104

3.3 Measurement Sheets

3.3.1 Return Loss and Smith Chart



TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 96 of 104

3.3.2 DASY4 H-Field Result

Date/Time: 21.04.2009 16:14:56

Test Laboratory: SPEAG Lab 2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1115

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: H3DV6 - SN6065; Calibrated: 22.12.2008
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 20.02.2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - measurement distance from the probe sensor center to CD1880 Dipole =

10mm/Hearing Aid Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.468 A/m

Probe Modulation Factor = 1.00

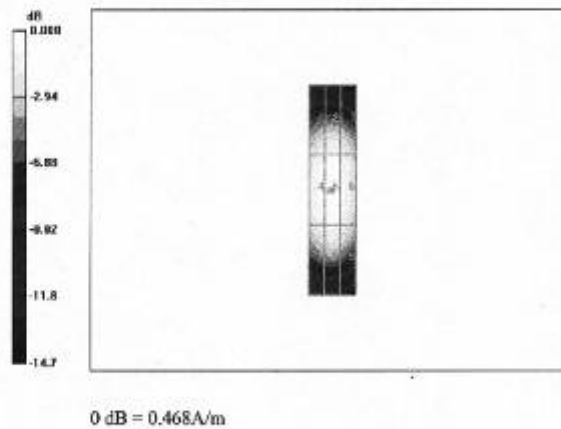
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.497 A/m; Power Drift = -0.028 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.410 M2	0.428 M2	0.405 M2
Grid 4	Grid 5	Grid 6
0.448 M2	0.468 M2	0.442 M2
Grid 7	Grid 8	Grid 9
0.409 M2	0.430 M2	0.403 M2



TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 97 of 104

3.3.3 DASY4 E-Field Result

Date/Time: 22.04.2009 15:33:14

Test Laboratory: SPEAG Lab 2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1115

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 - SN2336; ConvF(1, 1); Calibrated: 22.12.2008
- Sensor Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 20.02.2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 140.5 V/m

Probe Modulation Factor = 1.00

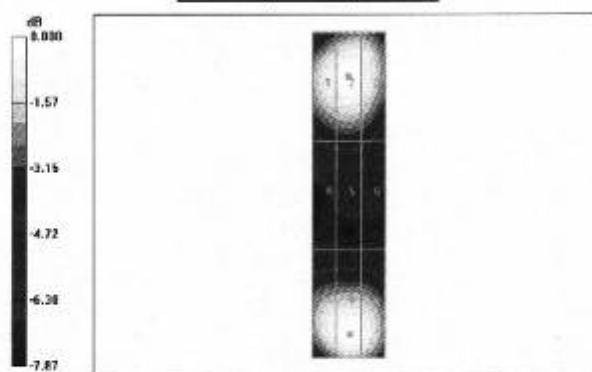
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 157.9 V/m; Power Drift = 0.005 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
133.8 M2	138.2 M2	134.2 M2
Grid 4	Grid 5	Grid 6
90.3 M3	92.5 M3	88.2 M3
Grid 7	Grid 8	Grid 9
132.9 M2	140.5 M2	137.0 M2



0 dB = 140.5V/m

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Test Report

Report No. RZA1111-1887HAC01

Page 98 of 104

ANNEX G: DAE4 Calibration Certificate

Calibration Laboratory of
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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **TA - SH (Auden)**

Certificate No: **DAE4-871_Nov10**

CALIBRATION CERTIFICATE

Object **DAE4 - SD 000 D04 BJ - SN: 871**

Calibration procedure(s) **QA CAL-06.v22**
Calibration procedure for the data acquisition electronics (DAE)

Calibration date: **November 18, 2010**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	28-Sep-10 (No.10376)	Sep-11
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Calibrator Box V1.1	SE UMS 006 AB 1004	07-Jun-10 (in house check)	In house check: Jun-11

Calibrated by:	Name	Function	Signature
	Andrea Guntli	Technician	
Approved by:	Name	Function	Signature
	Fin Bornholt	R&D Director	

Issued: November 18, 2010

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Certificate No: DAE4-871_Nov10

Page 1 of 5

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01

Page 99 of 104

Calibration Laboratory of
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Accreditation No.: **SCS 108**

Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- **DC Voltage Measurement:** Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- **Connector angle:** The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - **DC Voltage Measurement Linearity:** Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - **Common mode sensitivity:** Influence of a positive or negative common mode voltage on the differential measurement.
 - **Channel separation:** Influence of a voltage on the neighbor channels not subject to an input voltage.
 - **AD Converter Values with inputs shorted:** Values on the internal AD converter corresponding to zero input voltage
 - **Input Offset Measurement:** Output voltage and statistical results over a large number of zero voltage measurements.
 - **Input Offset Current:** Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - **Input resistance:** Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - **Low Battery Alarm Voltage:** Typical value for information. Below this voltage, a battery alarm signal is generated.
 - **Power consumption:** Typical value for information. Supply currents in various operating modes.

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA1111-1887HAC01
104

Page 100 of

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV

Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.757 $\pm$ 0.1% (k=2)	404.740 $\pm$ 0.1% (k=2)	405.181 $\pm$ 0.1% (k=2)
Low Range	3.98219 $\pm$ 0.7% (k=2)	3.93489 $\pm$ 0.7% (k=2)	3.96831 $\pm$ 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	90.0 $^{\circ}$ $\pm$ 1 $^{\circ}$
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TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA1111-1887HAC01
104

Page 101 of

Appendix

1. DC Voltage Linearity

High Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	200001.2	-1.56	-0.00
Channel X + Input	20000.71	0.71	0.00
Channel X - Input	-19997.87	1.63	-0.01
Channel Y + Input	199994.3	1.99	0.00
Channel Y + Input	19998.92	-1.08	-0.01
Channel Y - Input	-20000.26	-0.76	0.00
Channel Z + Input	200009.2	-1.04	-0.00
Channel Z + Input	19998.70	-1.10	-0.01
Channel Z - Input	-20000.16	-0.76	0.00

Low Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	2000.1	0.16	0.01
Channel X + Input	199.58	-0.52	-0.26
Channel X - Input	-200.79	-0.89	0.45
Channel Y + Input	1999.9	-0.03	-0.00
Channel Y + Input	199.45	-0.55	-0.27
Channel Y - Input	-200.31	-0.41	0.21
Channel Z + Input	2000.1	0.33	0.02
Channel Z + Input	199.13	-0.77	-0.38
Channel Z - Input	-201.47	-1.37	0.69

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	14.25	12.86
	- 200	-12.68	-14.21
Channel Y	200	-10.04	-10.39
	- 200	9.20	9.17
Channel Z	200	-0.85	-1.40
	- 200	-0.34	-0.31

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	2.85	0.69
Channel Y	200	2.41	-	2.73
Channel Z	200	2.54	0.73	-

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Test Report

Report No. RZA1111-1887HAC01
104

Page 102 of

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15920	15517
Channel Y	16171	16732
Channel Z	15803	16474

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	0.03	-2.35	0.86	0.43
Channel Y	-0.50	-1.49	-0.49	0.38
Channel Z	-0.92	-2.21	0.14	0.44

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (k Ω m)	Measuring (M Ω m)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9